## **Errata**

Title & Document Type: 1650B/1651B Logic Analyzer Service Manual

Manual Part Number: 01650-90924

Revision Date: February 1992

## **HP References in this Manual**

This manual may contain references to HP or Hewlett-Packard. Please note that Hewlett-Packard's former test and measurement, semiconductor products and chemical analysis businesses are now part of Agilent Technologies. We have made no changes to this manual copy. The HP XXXX referred to in this document is now the Agilent XXXX. For example, model number HP8648A is now model number Agilent 8648A.

## About this Manual

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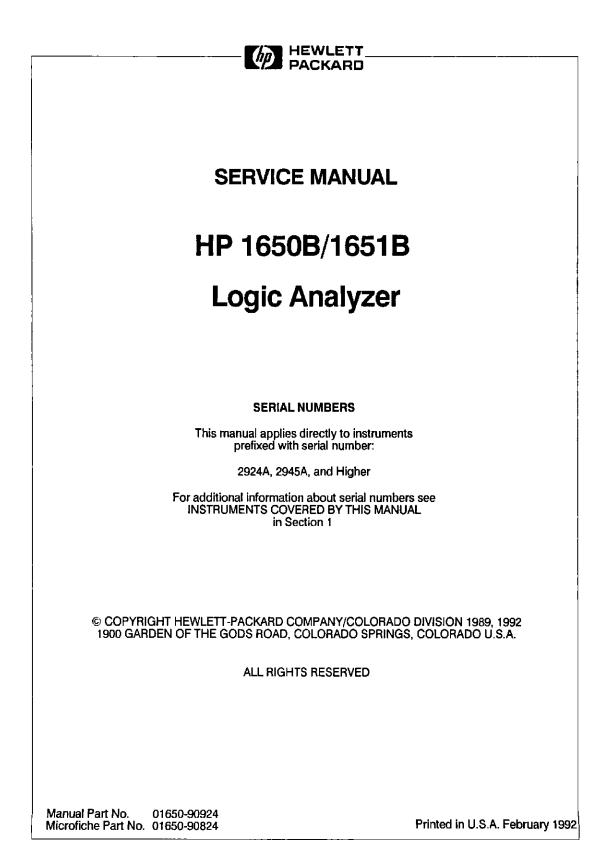
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#### Herstellerbescheinigung

Hiermit wird bescheinigt, daβ das Gerät/System in Übereinstimmung mit den Bestimmungen von Postverfügung 1046/84 funkentstört ist.

Der Deutschen Bundespost wurde das Inverkehrbringen dieses Gerätes/Systems angezeigt und die Berechtigung zur Überprüfung der Serie auf Einhaltung der Bestimmungen eingeräumt.

Zusatzinformation für Meß- und Testgeräte

Werden Meß- und Testgeräte mit ungeschirmten Kabeln und/oder in offenen Meßaufbauten verwendet, so ist vom Betreiber sicherzustellen, daß die Funkentstörbestimmungen unter Betriebsbedingungen an seiner Grundstücksgrenze eingehalten werden.

### Manufacturer's declaration

This is to certify that this product meets the radio frequency interference requirements of directive 1046/84. The German Bundespost has been notified that this equipment was put into circulation and was granted the right to check the product type for compliance with these requirements.

Additional Information for Test and Measurement Equipment

Note: If test and measurement equipment is operated with unshielded cables and/or used for measurements on open set-ups, the user must insure that under these operating conditions, the radio frequency interference limits are met at the border of his premises.

Safety Considerations		
General Operation	This is a Safety Class I instrument (provided with terminal for protective earthing). BEFORE APPLYING POWER verify that the power transformer primary is matched to the available line voltage, the correct fuse is installed, and Safety Precautions are taken (see the following warnings). In addition, note the instrument's external markings which are described under "Safety Symbols."	
General Warnings and Cautions	<ul> <li>BEFORE SWITCHING ON THE INSTRUMENT, the protective earth terminal of the instrument must be connected to the protective conductor of the (mains) powercord. The mains plug shall only be inserted in a socket outlet provided with a protective earth contact. The protective action must not be negated by the use of an extension cord (power cable) without a protective conductor (grounding). Grounding one conductor of a two-conductor outlet is not sufficient protection.</li> </ul>	
	<ul> <li>Servicing instructions are for use by service-trained personnel. To avoid dangerous electric shock, do not perform any servicing unless qualified to do so.</li> </ul>	
	<ul> <li>If this instrument is to be energized via an auto-transformer (for voltage reduction) make sure the common terminal is connected to the earth terminal of the power source.</li> </ul>	
	<ul> <li>Any interruption of the protective (grounding) conductor (inside or outside the instrument) or disconnecting the protective earth terminal will cause a potential shock hazard that could result in personal injury.</li> </ul>	
	<ul> <li>Whenever it is likely that the protection has been impaired, the instrument must be made inoperative and be secured against any unintended operation</li> </ul>	
	• Only fuses with the required rated current, voltage, and specified type (normal blow, time delay, etc.) should be used. Do not use repaired fuses or short circuited fuseholders. To do so could cause a shock or fire hazard	
	<ul> <li>Do not operate the instrument in the presence of flammable gasses or fumes. Operation of any electrical instrument in such an environment constitutes a definite safety hazard</li> </ul>	
	• Do not install substitute parts or perform any unauthorized modification to the instrument.	
	<ul> <li>Adjustments described in the manual are performed with power supplied to the instrument while protective covers are removed. Energy available at many points may, if contacted, result in personal injury.</li> </ul>	
	<ul> <li>Any adjustment, maintenance, and repair of the opened instrument under voltage should be avoided as much as possible, and when inevitable, should be carried out only by a skilled person who is aware of the hazard involved.</li> </ul>	
	<ul> <li>Capacitors inside the instrument may still be charged even if the instrument has been disconnected from its source of supply.</li> </ul>	
	Safety Symbols	
$\triangle$	Instruction manual symbol. The product will be marked with this symbol when it is necessary for the user to refer to the instruction manual in order to protect against damage to the product.	
\$	Indicates Hazardous Voltages	
	Earth terminal (sometimes used in manual to indicate circuit common connected to grounded chassis).	
Warning 🍟	The WARNING sign denotes a hazard It calls attention to a procedure, practice, or the like, which, if not correctly performed or adhered to, could result in personal injury. Do not proceed beyond a WARNING sign until the indicated conditions are fully understood and met.	
Caution 🖐	The CAUTION sign denotes a hazard. It calls attention to an operating procedure, practice, or the like, which, if not correctly performed or adhered to, could result in damage to or destruction of part or all of the product. Do not proceed beyond a CAUTION sign until the indicated conditions are fully understood or met.	

## **Printing History**

New editions are complete revisions of the manual. Update packages, which are issued between editions, contain additional and replacement pages to be merged into the manual by the customer. The dates on the title page change only when a new edition is published.

A software and/or firmware code may be printed before the date; this indicates the version level of the software and/or firmware of this product at the time of the manual or update was issued. Many product updates and fixes do not require manual changes and, conversely, manual corrections may be done without accompanying product changes. Therefore, do not expect a one to one correspondence between product updates and manual updates.

Edition 1	August 1989	01650-90915
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## **List of Effective Pages**

The List of Effective Pages gives the date of the current edition and of any pages changed in updates to that edition. Within the manual, any page changed since the last edition is indicated by printing the date the changes were made on the bottom of the page. If an update is incorporated when a new edition of the manual is printed, the change dates are removed from the bottom of the pages and the new edition date is listed in Printing History and on the title page.

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## Section 1

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# **General Information**

Introduction	This service manual explains how to test, adjust, and service the HP 1650B and HP 1651B Logic Analyzers. This manual is divided into six sections:
	General Information
	• Installation
	• Performance Tests
	• Adjustments
	Replaceable Parts
	Service
	This section of the manual includes a description of the HP 1650B/51B Logic Analyzers, specifications, options, available accessories, and recommended test equipment.
	Listed on the title page of this manual is a microfiche part number. This number can be used to order 4 X 6 inch microfilm transparencies of the manual. Each microfiche contains up to 96 photo-duplicates of the manual pages. The microfiche package also includes the latest manual changes supplement and pertinent service notes.
Instruments Covered by this Manual	The instrument serial number is on the rear panel. Hewlett-Packard uses a two part serial number consisting of a four-digit prefix and a five-digit suffix separated by a letter (0000A00000). The prefix is the same for all identical instruments and changes only when a modification is made that affects parts compatibility. The suffix is assigned and is different for each instrument. This manual applies directly to instruments with the serial prefix shown on the title page.
	An instrument manufactured after the printing of this manual may have a serial number prefix that is not listed on the title page. This unlisted serial prefix indicates the instrument is different from those described in this manual. The manual for this newer instrument is accompanied by a manual changes supplement. This supplement contains "change information" that explains how to adapt the manual to the newer instrument.
	In addition to change information, the supplement may contain information for correcting errors in the manual. To keep this manual as current and accurate as possible, Hewlett-Packard recommends that you periodically request the latest manual change supplement. The supplement for this manual is identified with the manual print date and part number, both of which appear on the manual title page. Complimentary copies of the supplement are available from Hewlett-Packard.

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Safety Considerations	This product is a Safety Class 1 instrument (provided with a protective earth terminal). Review the instrument and manual for safety markings and instructions before operating. Specific warnings, cautions, and instructions are placed wherever applicable throughout the manual. These precautions must be observed during all phases of operation, service, and repair of the instrument. Failure to comply with these precautions or with specific warnings elsewhere in this manual violates safety standards of design, manufacture, and intended use of this instrument. Hewlett-Packard assumes no liability if the customer fails to comply with these safety requirements.
Product Description	The HP 1650B is an 80-channel STATE/TIMING (35 MHz/100 MHz) logic analyzer, selectable in 16-channel groupings. The HP 1651B is a 32-channel STATE/TIMING (25 MHz/100 MHz) analyzer, also selectable in 16-channel groupings. The user interface for both models consists of a panel keyboard with an RPG knob and a 9-inch, white-phosphor, high-resolution CRT for information display. A 3.5-inch Sony disk drive, for setup storage and information retrieval, is integral to the analyzers. An RS-232-C port, HP-IB port, and external arming trigger are available on the rear panel. The RS-232-C and HP-IB ports are used for printer hardcopy or for logic analyzer control via a controller. Either port can be used for hardcopy or control.
	<ul> <li>The following items are other main features of the logic analyzers.</li> <li>Simultaneous state/state, or simultaneous state/timing analysis.</li> <li>Time interval; number of states; pattern search; minimum, maximum, and average time interval statistics.</li> <li>Transitional timing to store data only when there is a transition.</li> <li>Clock qualifiers, storage qualification, time and number of state tagging, and prestore.</li> <li>Small lightweight, passive probing.</li> </ul>

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Accessories Supplied	The following accessories are supplied with the HP 1650B/51B Logic Analyzer.		
	• Woven probe cable (HP part number 01650-61607) with 40-pin connector on each side, 17 signal lines, 17 return lines, 2 power lines, and 2 power ground lines. Each power line supplies +5 volts for preprocessor power. Each cable supplies 600 milliamperes with a maximum power available from the HP 1650B/51B of 2 amperes. Five probe cables are supplied with the HP 1650B and two are supplied with the HP 1651B.		
	• Probe Tip Assemblies (HP part number 01650-61608) that provide 16 data channels, 1 clock channel, and 1 ground lead per pod assembly. The probe input specifications are listed in table 1-1. Five Probe Tip Assemblies are supplied with the HP 1650B and two are supplied with the HP 1651B.		
	<ul> <li>Grabbers for the probe tip assemblies are supplied in packages of 20 (HP part number 5959-0288). 100 grabbers (5 packages) are supplied with the HP 1650B and 40 grabbers (2 packages) are supplied with the HP 1651B.</li> </ul>		
	• Two operating system disks.		
	• One 2.3 meter (7.5 feet) power cord. See section 2 for available power cords.		
	• One operating and reference manual set.		
	• One service manual.		
	One RS-232-C Loopback Connector.		
Accessories	The following accessories are available for the HP 1650B/51B Logic Analyzer.		
Available			
	• Termination Adapter - HP Part Number 01650-63201.		
	Soft Carrying Case - HP Part Number 1540-1066.		
	• HP 1008A /006 Testmobile.		

- HP 92192A 3.5-inch Microfloppy Disks (box of ten)
- Rackmount Kit HP Part Number 5061-6175.
- HP Model 10269C Probe interface to connect the logic analyzer directly to microprocessor preprocessors.

• Preprocessors for specific microprocessors and bus systems (for more information contact your Hewlett-Packard Sales and Service Office).

Probes	Minimum Swing: 600 mV peak-to-peak.		
	Threshold Accuracy:	Voltage Range	Accuracy
		-2.0V to +2.0V	± 150 mV
		-9.9V to -2.1V	± 300 mV
		+2.1V to +9.9V	$\pm 300 \text{ mV}$

**State Mode** Clock Repetition Rate: Single phase is 35 MHz maximum. With time or state counting, minimum time between states is 60 ns (16.67 MHz). Both mixed and demultiplexed clocking use master-slave clock timing; master clock must follow slave clock by at least 10 ns and precede the next slave clock by  $\geq$ 50 ns.

**Clock Pulse Width:**  $\geq 10$  ns at threshold.

Setup Time: Data must be present prior to clock transition,  $\geq 10$  ns.

Hold Time: Data must be present after rising clock transition; 0 ns.

Data must be present after falling clock transition, 0 ns (HP 1651B); data must be present after falling L clock transition, 0 ns (HP 1650B); data must be present after falling J, K, M, and N clock transition, 1 ns (HP 1650B).

Timing Mode Minimum Detectable Glitch: 5 ns wide at the threshold.

Operating	The following operating characteristics are are typical operating characteristics for
Characteristics	the HP 1650B/51B Logic Analyzer.

**Probes** Input RC: 100 K $\Omega$  ± 2% shunted by approximately 8 pF at the probe tip.

TTL Threshold Preset: +1.6 volts.

ECL Threshold Preset: -1.3 volts.

Threshold Range: -9.9 to +9.9 volts in 0.1V increments.

**Threshold Setting:** Threshold levels may be defined for pods 1 and 2 individually (HP 1651B). Threshold levels may be defined for pods 1, 2, and 3 on an individual basis and one threshold may be defined for pods 4 and 5 (HP 1650B).

Minimum Input Overdrive: 250 mV or 30% of the input amplitude, whichever is greater.

Maximum Voltage: ± 40 volts peak.

Maximum Power Available Through Cables: (600 mA) 2/3 amp @ 5V per cable; 2 amp @ 5V per HP 1650B/51B.

## Measurement

**Configurations** Analyzer Configurations:

<u>Analyzer 2</u>
Off
Timing
Off
State
State
Timing
State
Off

**Channel Assignment:** Each group of 16 channels (a pod) can be assigned to Analyzer 1, Analyzer 2, or remain unassigned. The HP 1650B contains 5 pods; the HP 1651B contains 2 pods.

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#### State Analysis MEMORY

Data Acquisition: 1024 samples/channel.

#### **Trace Specification**

**Clocks:** Five clocks (HP 1650B) or two clocks (HP 1651B) are available and can be used by either one or two state analyzers at any time. Clock edges can be ORed together and operate in single phase, two phase demultiplexing, or two phase mixed mode. Clock edge is selectable as positive, negative, or both edges for each clock.

**Clock Qualifier:** The high or low level of four ORed clocks (HP 1650B) or one clock (HP1651B) can be ANDed with the clock specification. Setup time: 20 ns; hold time: 5 ns.

**Pattern Recognizers:** Each recognizer is the AND combination of bit (0, 1, or X) patterns in each label. Eight pattern recognizers are available when one state analyzer is on. Four are available to each analyzer when two state analyzers are on.

**Range Recognizers:** Recognizes data which is numerically between or on two specified patterns (ANDed combination of 0s and/or 1s). One range term is available and is assigned to the first state analyzer turned on. The maximum size is 32 bits and on a maximum of 2 pods.

Qualifier: A user-specified term that can be anystate, nostate, a single pattern recognizer, range recognizer, or logical combination of pattern and range recognizers.

**Sequence Levels:** There are eight levels available to determine the sequence of events required for trigger. The trigger term can occur anywhere in the first seven sequence levels.

**Branching:** Each sequence level has a branching qualifier. When satisfied, the analyzer will restart the sequence or branch to another sequence level.

**Occurrence Counter:** Sequence qualifier may be specified to occur up to 65535 times before advancing to the next level.

**Storage Qualification:** Each sequence level has a storage qualifier that specifies the states that are to be stored.

**Enable/Disable:** Defines a window of post-trigger storage. States stored in this window can be qualified.

Prestore: Stores two qualified states that precede states that are stored.

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#### Tagging

**State Tagging:** Counts the number of qualified states between each stored state. Measurement can be shown relative to the previous state or relative to trigger. Maximum count is 4.4 X (10 to the 12th power).

**Time Tagging:** Measures the time between stored states, relative to either the previous state or the trigger. Maximum time between states is 48 hours.

With tagging on, the acquisition memory is halved; minimum time between states is 60 ns.

#### Symbols

**Pattern Symbols:** User can define a mnemonic for the specific bit pattern of a label. When data display is SYMBOL, mnemonic is displayed where the bit pattern occurs. Bit pattern can include 0s, 1s, and don't cares.

**Range Symbols:** User can define a mnemonic covering a range of values. Bit pattern for lower and upper limits must be defined as a pattern of 0s and 1s. When data display is SYMBOL, values within the specified range are displayed as mnemonic + offset from base of range.

Number of Pattern and Range Symbols: 200 total used for both analyzers.

Symbols can be down-loaded over RS-232-C or HP-IB.

#### Timing Analysis Transitional Timing Mode

Sample is stored in acquisition memory only when the data changes. A time tag stored with each sample allows reconstruction of waveform display. Time covered by a full memory acquisition varies with the number of pattern changes in the data.

Sample Period: 10 ns.

Maximum Time Covered By Data: 5000 seconds.

Minimum Time Covered by Data: 10.24 us.

#### **Glitch Capture Mode**

Data sample and glitch information stored every sample period.

**Sample Period:** 20 ns to 50 ms in a 1-2-5 sequence dependent on sec/div and delay settings.

Memory Depth: 512 samples/channel.

Time Covered by Data: Sample period X 512.

#### Waveform Display

Sec/div: 10 ns to 100 s; 0 01% resolution.

**Delay:** -2500 s to 2500 s; presence of data dependent on the number of transitions in data between trigger and trigger plus delay (transitional timing).

Accumulate: Waveform display is not erased between successive acquisitions.

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General Information 1-7 **Overlay Mode:** Multiple channels can be displayed on one waveform display line. Primary use is to view summary of bus activity.

#### Maximum Number Of Displayed Waveforms: 24

#### **Time Interval Accuracy**

Channel to Channel Skew: 4 ns typical.

**Time Interval Accuracy:**  $\pm$  (sample period + channel-to-channel skew + 0.01% of time interval reading).

#### **Trigger Specification**

**Asynchronous Pattern:** Trigger on an asynchronous pattern less than or greater than specified duration. Pattern is the logical AND of specified low, high, or don't care for each assigned channel. If pattern is valid but duration is invalid, there is a 20 ns reset time before looking for patterns again.

Greater Than Duration: Minimum duration is 30 ns to 10 ms with 10 ns or  $0.01^{\circ}$ resolution, whichever is greater. Accuracy is +0 ns to -20 ns. Trigger occurs at pattern + duration.

**Less Than Duration:** Maximum duration is 40 ns to 10 ms with 10 ns or 0.01% resolution, whichever is greater. Pattern must be valid for at least 20 ns. Accuracy is +20 ns to -0 ns. Trigger occurs at the end of the pattern.

Glitch/Edge Triggering: Trigger on glitch or edge following valid duration of asynchronous pattern while the pattern is still present. Edge can be specified as rising, falling or either. Less than duration forces glitch and edge triggering off.

### Measurement and Autoscale (Timing Analyzer Only) Display Functions

Autoscale scarches for and displays channels with activity on the pods assigned to the timing analyzer.

#### **Acquisition Specifications**

Arming: Each analyzer can be armed by the run key, the other analyzer, or the external trigger on rear panel.

**Trace Mode:** Single mode acquires data once per trace specification; repetitive mode repeats single mode acquisitions until stop is pressed or until time interval between two specified patterns is less than or greater than a specified value, or within or not within a specified range. There is only one trace mode when two analyzers are on.

#### Labels

Channels may be grouped together and given a six character name. Up to 20 labels in each analyzer may be assigned with up to 32 channels per label. Primary use is for naming groups of channels such as address, data, and control busses.

#### Indicators

Activity Indicators: Provided in the Configuration, State Format, and Timing Format menus for identifying high, low, or changing states on the inputs.

Markers: Two markers (X and 0) are shown as dashed lines on the display.

**Trigger:** Displayed as a vertical dashed line in the timing waveform display and as line 0 in the state listing display.

#### **Marker Functions**

Time Interval: The X and 0 markers measure the time interval between one point on a timing waveform and trigger, two points on the same timing waveform, two points on different waveforms, or two states (time tagging on).

**Delta States (State Analyzer Only):** The X and 0 markers measure the number of tagged states between one state and trigger, or between two states.

**Patterns:** The X and 0 markers can be used to locate the nth occurrence of a specified pattern before or after trigger, or after the beginning of data. The 0 marker can also find the nth occurrence of a pattern before or after the X marker.

**Statistics:** X to 0 marker statistics are calculated for repetitive acquisitions. Patterns must be specified for both markers and statistics are kept only when both patterns can be found in an acquisition. Statistics are minimum X to 0 time, maximum X to 0 time, average X to 0 time, and ratio of valid runs to total runs.

#### **Run/Stop Functions**

Run: Starts acquisition of data in specified trace mode.

Stop: In single trace mode or the first run of a repetitive acquisition, STOP halts acquisition and displays the current acquisition data. For subsequent runs in repetitive mode, STOP halts acquisition of data and does not change current display.

#### **Data Display/Entry**

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**Display Modes:** State listing; timing waveforms; interleaved, time-correlated listing of two state analyzers (time tagging on); time-correlated state listing and timing waveform display (state listing in upper half, timing waveform in lower half, and time tagging on).

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Timing Waveform: Pattern readout of timing waveforms at X or 0 marker.

**Bases:** Binary, Octal, Decimal, Hexadecimal, ASCII (display only), and User-defined symbols.

General Characteristics	The following general characteristics for the HP 1650B/51B are the environmental operating conditions, shipping weights, and instrument dimensions.
Operating Environment	<b>Temperature:</b> Instruments, $0^{\circ}$ to 55° C (+32° to 131°F); probes and cables, $0^{\circ}$ to 65°C (+32° to 149°F). Recommended temperature range for disk media, 10° to 50°C (+50° to 149°F).
HP 1650B/1651B	General Information

Humidity: Instruments up to 95% relative humidity at  $+40^{\circ}$ C; (104°F). Recommended humidity range for disk media, 8% to 80% relative humidity at  $+40^{\circ}$ C ( $+104^{\circ}$ F).

Altitude: To 4600 m (15,000 ft).

Vibration:

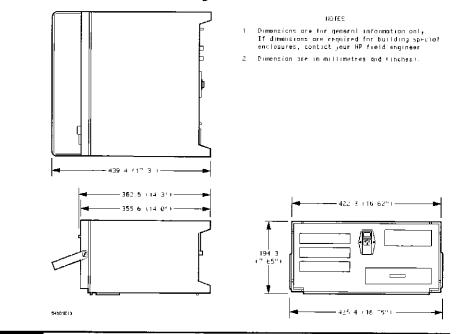
Operating: Random vibration 5-500 Hz, 10 minutes per axis, &2.41 g (rms).

Non-operating: Random vibration 5-500 Hz, 10 minutes per axis, & 2.41 g (rms); and swept sine resonant search, 5-500 Hz, 0.75 g (0-peak), 5 minute resonant dwell @ 4 resonances per axis.

Weight: 10.0 kg (22 lbs) net; 18.2 kg (40 lbs) shipping.

Power: 115V/230V, 48-66 Hz, 200 W maximum.

Dimensions: See outline drawing below.



## Recommended Test Equipment

Table 1-1 lists the test equipment required to test performance, make adjustments, and troubleshoot the HP 1650B/51B Logic Analyzers. The table includes the critical specifications of the test equipment and lists each procedure in which the equipment is required Other equipment may be substituted if it meets or exceeds the critical specifications listed in the table.

Equipment Required	Critical Specifications	Recommended Model	Use *	
Oscilloscope	dual channel     HP 54502A       dc to 300 MHz     HP 54502A		P,T	
Pulse Generator	5 ns pulse widthHP 8161A/02020 ns period1.3 ns risetimedouble pulse100 kHz Repetition RateOvershoot: $5^{c}c$ of Amp.		P	
Power Supply	+ or - 10.2 V output current: 0 - 0.4 amperes	HP 6216B	P	
Adapter	BNC(f)-to-Dual Banana	HP Part Number 1251-2277	P	
DMM	5.5 digit resolution	HP 3478A	A	
Resistor	2 ohms, 25 watts	HP Part Number 0811-1390		
BNC Cable (2)	50 ohms with UG-88C/U BNC (m) connectors	HP 10503A	P	
BNC Adapter (2)	BNC tee (m) (f) (f) HP Part Number 1250-0781		Р	
BNC Feedthrough	50 ohm BNC	HP 10100C	Р	

Table 1-1.	Recommended Test Equi	pment
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General Information 1-11 -----

## Section 2

### Installation

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## Instaliation

| Introduction                     | This section of the manual contains information and instructions necessary for<br>setting up the HP 1650B/51B Logic Analyzer. This includes inspection<br>procedures, power requirements, hardware connections and configurations, and<br>packaging information.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
|----------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Safety<br>Considerations         | The safety symbols used with Hewlett-Packard instruments are illustrated in the front of this manual. WARNING and CAUTION symbols and instructions should be reviewed before operating the instrument. These warnings and cautions must be followed for your own protection and to avoid damaging the instrument.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                |
| Initial<br>Inspection            | Inspect the shipping container for damage. If the shipping container or cushioning material is damaged, keep it until the contents of the shipment have been checked for completeness and the instrument has been checked mechanically and electrically. The contents of the shipment are listed under "Accessories Supplied" in Section 1. If the contents are incomplete, if there is mechanical damage or defect, or if the instrument does not operate properly, notify the nearest Hewlett-Packard office. If the shipping container is damaged, or the cushioning materials show signs of stress, notify the carrier as well as the Hewlett-Packard office. Keep the shipping materials for the carrier's inspection. The Hewlett-Packard office will arrange for repair or replacement at HP option without waiting for claim settlement. |
| Power<br>Requirements<br>Caution | The HP 1650B/51B Logic Analyzer requires a power source of either 115 Vac or 230 Vac, -22% to +10%; single phase, 48 to 66 Hz, 200 Watts maximum power.<br>BEFORE CONNECTING POWER TO THIS INSTRUMENT, be sure the Line Voltage Select switch on the rear panel of the instrument is set properly and the correct fuse is installed.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                             |

- -----

2

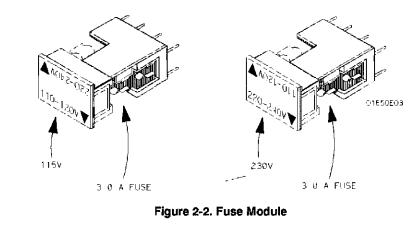
| Line Voltage<br>Selection | When shipped from the factory, the line voltage selector is set and an appropriate fuse is installed for operating the instrument in the country of destination. |  |
|---------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|--|
|                           | To operate the instrument from a power source other than the one set at the factory:                                                                             |  |
|                           | 1. Turn the rear power switch to the OFF position and remove the power cord from the instrument.                                                                 |  |
|                           | 2. Remove the fuse module by carefully prying it at the top center of the module until you can grasp it and pull it out by hand as shown below.                  |  |
|                           | 17 LEA                                                                                                                                                           |  |
|                           |                                                                                                                                                                  |  |

, ' ,



8 165**0**580

3. Reinsert the fuse module with the arrows aligned for your application. See fuse module below.



4. Reconnect the power cord, turn the rear power switch to the ON position, and continue normal operation.

| Power Cable                    | This instrument is equipped with a three-wire power cable. When connected to an appropriate AC power outlet, this cable grounds the instrument cabinet. The type of power cable plug shipped with the instrument depends on the country of destination. See Table 2-1 for the option numbers of available power cables and plug configurations. |
|--------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Operating Disk<br>Installation | This instrument is shipped with a yellow protective disk in the disk drive. Before<br>applying power to the instrument, remove the protective disk from the disk drive<br>and install the operating disk. Reinstall the protective disk whenever the<br>instrument is to transported.                                                           |
| Applying Power                 | When power is applied to the HP 1650B/51B, a power-up self test is automatically performed. For information on the power-up self test, refer to section 3.                                                                                                                                                                                      |

--- --- -- --

## Table 2-1. Power Plug Configurations

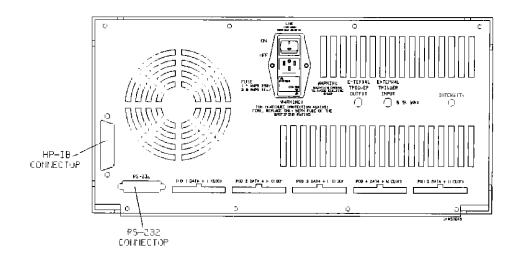
| PLUG TYPE | CABLE<br>Part No.                   | PLUG DESCRIPTION                                          | LENG TH<br>IN/CM           | COLOR                                | COUNTRY                                                                                         |
|-----------|-------------------------------------|-----------------------------------------------------------|----------------------------|--------------------------------------|-------------------------------------------------------------------------------------------------|
| 250V      | 6120-1351<br>6120-1703              | Strought +851363A<br>90°                                  | 90 228<br>90 228           | Gray<br>Hint Gray                    | United Fingdom,<br>Cyprus,<br>Nigeria,<br>Zimbobwe<br>Singapore                                 |
| 250V      | 6120–1369<br>6120–0695              | Strought +NIS5138 ASC<br>90°                              | 79-200<br>87-221           | Gray<br>Mint Gray                    | Australia<br>New Zealand                                                                        |
| 2504      | 6120-1683<br>6120-1692<br>8120-2857 | Straight +CEET-+11<br>gan⁰<br>Straight (Shielded)         | 79-200<br>79+200<br>7++200 | Mint Gray<br>Mint Gray<br>Coco Brown | Epst and West Europe,<br>Soud: Arabia,<br>So Africa,<br>India (Unpolarized<br>in many nations)  |
| 0PT 303++ | 8120-1576<br>8120-1521<br>8120-1392 | Straight +NEMA515P<br>90°<br>Straight (Medicai)<br>ULS4-1 | 90 228<br>90 228<br>96 244 | lade Gray<br>Jade Gray<br>Black      | United States,<br>Canada,<br>Merico<br>Philipines,<br>Taiwan                                    |
| 0PT 904++ | 8120-0698                           | Straight •NEMA6-15P                                       | 9J 228                     | Bi at i                              | United States<br>Canada                                                                         |
| 0PT 905   | 8120-1396<br>8120-1625              | EEE22-vi<br>'System Cobinet Usel :<br>250v                | 30 76<br>96 244            | Jade Gray                            | For interconnecting<br>system components and<br>peripherals<br>United States and<br>Canada only |
| 250-      | 8120-2104<br>8120-2296              | Straight +9EV1011<br>1959-2450™<br>Type 12<br>190°        | 79 200<br>74 200           | Mint Snav<br>Mint Gnav               | Switzerland.                                                                                    |
| 200V      | 8120-2956<br>8120-2957              | Stright +DHCF107<br>ajº                                   | 79 200<br>79 200           | Mint Gray<br>Mint Gray               | Denmark                                                                                         |
| 250V      | B120-4211<br>B120-4600              | Straight S∆8S164<br>30°                                   | 79.200<br>79.200           | Jade Gray                            | Pepublic of South Africa<br>India                                                               |
| OPT AIR   | 8120-4752<br>8120-4754              | Straight Miti<br>492                                      | 90 230<br>90 230           | Dark Gray                            | .Jd⊊ dri                                                                                        |

#Provis
 Port number shown for plug is industry identifier for plug unly. Number shown for sable is HP part number for
 complete vable including plug.
 \*\*These cords are included in the CSA certification approval of the equipment.
 E=Eurth Ground
 L=Eure
N=Reutral

Installation 2-4

HP 1650B/1651B Service Manual

| User Interface       | <ul> <li>The front-panel user interface of the HP 1650B/51B consists of front-panel keys, the KNOB, and display. The interface allows configuration of each analyzer (machine) within the logic analyzer. It also displays acquired data and measurement results.</li> <li>Use the front-panel interface with the following process: <ul> <li>select the desired menu with menu keys</li> <li>place the cursor on the desired field within the menu by rotating the KNOB</li> <li>display the field options or current data by pressing the SELECT key</li> <li>select the desired option by rotating the KNOB or entering new data by using the KNOB or the keypad</li> <li>Start and stop data acquisition by using the RUN and STOP keys</li> </ul> </li> </ul> |
|----------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| HP-IB<br>Interfacing | The Hewlett-Packard Interface Bus (HP-IB) is Hewlett-Packard's implementation<br>of IEEE Standard 488-1978, "Standard Digital Interface for Programming<br>Instrumentation." HP-IB is a carefully defined interface that simplifies the<br>integration of various instruments and computers into systems. The interface<br>makes it possible to transfer messages between two or more HP-IB compatible<br>devices. HP-IB is a parallel bus of 16 active signal lines divided into three<br>functional groups according to function.<br>Eight signal lines, called data lines, are in the first functional group. The data lines<br>are used to transmit data in coded messages. These messages are used to program                                                 |
|                      | the instrument function, transfer measurement data, and coordinate instrument<br>operation. Input and output of all messages, in bit parallel-byte serial form, are<br>also transferred on the data lines. A 7-bit ASCII code normally represents each<br>piece of data.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |
|                      | Data is transferred by means of an interlocking "Handshake" technique which<br>permits data transfer (asynchronously) at the rate of the slowest active device used<br>in that transfer. The data byte control lines coordinate the handshaking and form<br>the second functional group.                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |
|                      | The remaining five general interface management lines (third functional group) are used to manage the devices connected to the HP-IB. This includes activating all connected devices at once, clearing the interface, and other operations.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
|                      | The HP-IB connector and on the rear panel are shown in figure 2-3.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 |





| HP-IB Address<br>Selection | Each instrument connected to the HP-IB interface bus requires a unique address.<br>The address provides a method for the system computer to select individual<br>instruments on the bus. The address of the HP 1650B/51B defaults at power up to<br>decimal "07". The corresponding ASCII code is a listen of "" and a talk address of<br>"G." To change the address of the HP 1650B/51B proceed as follows: |
|----------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                            | <ol> <li>Press the I/O key on the front-panel keypad and the I/O menu will appear on<br/>screen.</li> </ol>                                                                                                                                                                                                                                                                                                  |
|                            | 2. Rotate the KNOB until "I/O Port Configuration" is highlighted.                                                                                                                                                                                                                                                                                                                                            |
|                            | <ol><li>Press the SELECT key and the External I/O Port Configuration menu will<br/>appear on screen.</li></ol>                                                                                                                                                                                                                                                                                               |

| Externol 1/0 Port Configuration | Dane                                |
|---------------------------------|-------------------------------------|
| Printer connected to PS-232-C   | Controller connected to <u>HPIE</u> |
| R5-252-C Configuration          | NPIB Configuration                  |
| Protocol i XON74DFF             | HPIB Address v 🛛 7                  |
| Stop Bits / 🗌                   |                                     |
| Perity None                     |                                     |
| Baud rate ( 9600 -              |                                     |
| Date Dits O                     |                                     |
| Printer Information             |                                     |
| Printer + LoserJet P            | nper Hidth 6.5'                     |

Figure 2-4. External I/O Port Configuration Menu

- 4. Select the HP-IB Address field with the KNOB and press the SELECT key.
- 5. When the pop-up field appears on screen, rotate the KNOB to select the desired HP-IB address.
- 6. Press the SELECT key to enter the new address.
- 7. Select the DONE field in the upper-right corner with the KNOB to exit the External I/O Port Configuration menu.

## RS-232-C Interface

The HP 1650B/51B interfaces with RS-232-C communication lines through a standard 25 pin D connector. The HP 1650B/51B is compatible with RS-232-C protocol. When a hardwire handshake method is used, the Data Terminal Ready (DTR) line (pin 20 on the Computer/Modem connector) is used to signal whether space is available in the logical I/O buffer for more data. Pin outs of the RS-232-C connectors are listed in table 2-4.

| Pin No. | RS-232-C<br>Function      | Standard | Signal Direction and Level                                                                                  |
|---------|---------------------------|----------|-------------------------------------------------------------------------------------------------------------|
| 1       | Protective Ground         | AA       | Not applicable                                                                                              |
| 2       | Transmitted Data (TD)     | BA       | Data from Logic Analyzer<br>High = Space = "0" = + 12 V<br>Low = Mark = "1" = -12 V                         |
| 3       | Received Data (RD)        | BB       | Data to Logic Analyzer<br>High = Space = $"0" = +3 V \text{ to } +25 V$<br>Low = Mark = "1" = -3 V to -25 V |
| 4       | Request to Send (RTS)     | CA       | Signal from Logic Analyzer<br>High = ON = +12 V<br>Low = OFF = -12 V                                        |
| 5       | Clear to Send (CTS)       | СВ       | Signal to Logic Analyzer<br>High = $ON = +3 V$ to $+12 V$<br>Low = $OFF = -3 V$ to $-25 V$                  |
| 6.      | Data Set Ready (DSR)      | СС       | Signal to Logic Analyzer<br>High = $ON = +3V$ to $+25V$<br>Low = $OFF = -3V$ to $-25V$                      |
| 7       | Signal Ground             | AB       | Not applicable                                                                                              |
| 8       | Data Carrier Detect (DCD) | CF       | Signal to Logic Analyzer<br>High = $ON = +3 V$ to $+25 V$<br>Low = $OFF = -3 V$ to $-25 V$                  |
| 20      | Data Terminal Ready (DTR) | CD       | Signal from Logic Analyzer<br>High = ON = +12 V<br>Low = OFF = -12 V                                        |
| 23      | Data Signal Rate Selector | CH/CI    | Signal from Logic Analyer<br>Always High = ON = +12 V                                                       |
|         |                           |          |                                                                                                             |

## Table 2-1. RS-232-C Signal Definitions

| RS-232-C<br>Configuration | At power up, the RS-232-C interface is configured as shown in previous figure. To change the RS-232-C configuration: |
|---------------------------|----------------------------------------------------------------------------------------------------------------------|
|                           | 1. Press the I/O key on the front-panel keypad and the I/O menu will appear on screen.                               |
|                           | 2. Rotate the KNOB until "I/O Port Configuration" is highlighted.                                                    |
|                           | <ol> <li>Touch the SELECT key and the External I/O Port Configuration menu will<br/>appear on screen.</li> </ol>     |

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|                          | 4. Using the KNOB and SELECT key, configure the RS-232-C interface as desired.                                                                                                                                                                                                                                                 |
|--------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                          | 5. Select the DONE field in the upper-right corner with the KNOB to exit the<br>External I/O Port Configuration menu.                                                                                                                                                                                                          |
| Operating<br>Environment | The operating environment for the HP 1650B/51B is described in table 1-2. Note<br>the non-condensing humidity limitation. Condensation within the instrument<br>cabinet can cause poor operation or malfunction. Protection should be provided<br>against temperature extremes which cause condensation within the instrument. |
|                          | The HP 1650B/51B operates at all specifications within the temperature and humidity range given in table 1-2.                                                                                                                                                                                                                  |
| Storage and              | The instrument may be stored or shipped in environments within the following                                                                                                                                                                                                                                                   |
| Shipment                 | limits:                                                                                                                                                                                                                                                                                                                        |
| -                        |                                                                                                                                                                                                                                                                                                                                |
| -                        | limits:                                                                                                                                                                                                                                                                                                                        |
| -                        | limits:<br>Temperature:-40 degrees C to + 75 degrees C.                                                                                                                                                                                                                                                                        |

| Original<br>Packaging    | If the original packaging material is unavailable or unserviceable, materials<br>identical to those used in factory packaging are available through Hewlett-Packard<br>offices. If the instrument is to be shipped to a Hewlett-packard office for service,<br>attach a tag identifying the owner, address of the owner, complete instrument<br>model and serial numbers, and a description of the service required. Mark the<br>container FRAGILE to ensure careful handling. In any correspondence, refer to<br>the instrument by model number and full serial number. |
|--------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Other<br>Packaging       | The following general instructions should be followed for repacking the instrument with commercially available materials.                                                                                                                                                                                                                                                                                                                                                                                                                                                |
|                          | • Remove discs from disk drives and install yellow shipping discs.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
|                          | • Wrap the instrument in heavy paper or plastic.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |
|                          | <ul> <li>Use a strong shipping container. A double-wall carton made of 350 lb. test<br/>material is adequate.</li> </ul>                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
|                          | • Use a layer of shock-absorbing material 70 to 100 mm (3 to 4 inches) thick around all sides of the instrument to provide firm cushioning and prevent movement inside the container. Protect the control panel with cardboard.                                                                                                                                                                                                                                                                                                                                          |
|                          | • Seal the shipping container securely.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
|                          | • Mark the shipping container FRAGILE to ensure careful handling.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
|                          | • In any correspondence, refer to the instrument by model number and serial number.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                      |
|                          |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| Cleaning<br>Requirements | Use MILD SOAP AND WATER to clean the HP 1650B/51B cabinet and front<br>panel. Care must be taken to not use a harsh soap which may damage the<br>water-base paint finish of the instrument.                                                                                                                                                                                                                                                                                                                                                                              |

# Contents

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|           | Clock, Qualifier, and Data Inputs Test 2                 |  |
|           | Clock, Qualifier, and Data Inputs Test 3 (HP 1650B Only) |  |
|           | Clock, Qualifier, and Data Inputs Test 4                 |  |
|           | Clock, Qualifier, and Data Inputs Test 5                 |  |
|           | Clock, Qualifier, and Data Inputs Test 6                 |  |
|           | Glitch Test                                              |  |
|           | Threshold Accuracy Test                                  |  |

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## **Performance Tests**

| Introduction                  | These procedures test the electrical performance of the logic analyzer by using the specifications in table 1-1 as the performance standards. All tests may be performed without access to the interior of the instrument.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
|-------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Recommended<br>Test Equipment | Equipment required for the performance tests in this section is listed in the Recommended Test Equipment table in Section 1. Any equipment that satisfies the critical specification listed in the table may be substituted for the recommended model.                                                                                                                                                                                                                                                                                                                                                                                                                                                      |
| Test Connector                | The performance tests and adjustments require connecting pulse generator outputs to probe pod inputs. Figure 3-1 is a test connector that may be built to allow testing of multiple channels (up to eight at one time). The test connector consists of a BNC connector and a length of wire. Connecting more than eight channels to the test connector at a time will induce loading of the circuit and true signal representation will degrade. Test results may not be accurate if more than eight channels are connected to the test connector. The Hewlett-Packard part number for the BNC connector in figure below is 1250-1032. An equivalent part may be used in place of the Hewlett-Packard part. |
|                               | 01650E38                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    |
|                               | Figure 3-1. Test Connector                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
| Test Record                   | The results of the performance tests may be tabulated on the Test Record<br>provided at the end of this section. The Test Record lists the performance tests<br>and provides an area to mark whether the pod passed or failed the test. The<br>results recorded in the table at incoming inspection may be used for later<br>comparisons of the tests during periodic maintenance, troubleshooting, and after<br>repairs or adjustments.                                                                                                                                                                                                                                                                    |

HP 1650B/1651B Service Manual

Performance Tests 3-1

| Self Tests         | The power-up self test is automatically performed upon applying power to the logic analyzer. Since the performance tests require test equipment, self tests may be performed individually to provide a higher level of confidence that the instrument is operating properly. A message that the instrument has failed the test will appear if any problem is encountered during the test. The individual self tests may be performed for functions listed in the self test menu which is invoked via the I/O menu. The HP 1650B/51B self test is located on the operating system disk and is required to run the tests. |
|--------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Power-up Self Test | The power-up self test is automatically invoked at power-up of the HP 1650B/51B Logic Analyzer. The revision number of the operating system firmware is given in the upper right of the screen during the power-up self test. As each test completes, either passed or failed is printed in front of the name of the test in the following manner:                                                                                                                                                                                                                                                                      |

## PERFORMING POWER-UP SELF TESTS

- passed ROM test
- passed RAM test
- passed Interrupt test
- passed Display test
- passed Keyboard test
- passed Acquisition test
- passed Threshold test
- passed Disk test

#### LOADING SYSTEM FILE

As indicated by the last message, the HP 1650B/51B automatically loads the operating system disk in the disk drive. If the operating system disk is not in the disk drive, the message SYSTEM DISC NOT FOUND is displayed at the bottom of the screen and NO DISK is displayed in front of disk test in place of "passed".

If the above message appears, turn off the instrument, insert the operating system disk into the disk drive, and again apply power.

-- ----

Performance Tests 3-2

| Selectable Self<br>Tests     | Seven self tests may be invoked individually via the Self Test menu. The seven selectable self tests are:                                                                                                                                                                                                                                                                                                                                                                                                                                          |
|------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                              | <ul> <li>Data Acquisition</li> <li>RS-232-C</li> <li>External Trigger BNCs</li> <li>Keyboard</li> <li>RAM</li> <li>ROM</li> <li>Disk Drive</li> <li>Cycle through all tests</li> </ul>                                                                                                                                                                                                                                                                                                                                                             |
|                              | The required test is selected by moving the cursor to the test and pressing the front<br>panel SELECT key. A pop-up menu appears with a description of the test to be<br>performed. The self test does not begin until the cursor is placed on <b>Execute</b> and<br>the front panel SELECT key is pressed.                                                                                                                                                                                                                                        |
|                              | After the test has been completed, either <b>Passed</b> , <b>Failed</b> , or <b>Tested</b> is displayed on<br>the Self Test menu in front of the test. These tests are used as troubleshooting<br>aids. Section 6 contains information on the individual tests used for<br>troubleshooting.                                                                                                                                                                                                                                                        |
| Performance<br>Test Interval | The calibration cycle for the logic analyzer is two years, therefore, periodic<br>performance verification of the HP 1650B/51B is recommended at two year<br>intervals. The instrument's performance should be verified after it has been<br>serviced, or if improper operation is suspected. Calibration should be performed<br>before any performance verification tests. Further checks requiring access to the<br>interior of the instrument are included in the adjustment section, but are not<br>required for the performance verification. |
| Test Record                  | The results of the performance tests may be tabulated on the Test Record<br>provided at the end of this section. The Test Record lists the performance tests<br>and provides an area to mark whether the pod passed or failed the test. The<br>results recorded in the table at incoming inspection may be used for later<br>comparisons of the tests during periodic maintenance, troubleshooting, and after<br>repairs or adjustments.                                                                                                           |

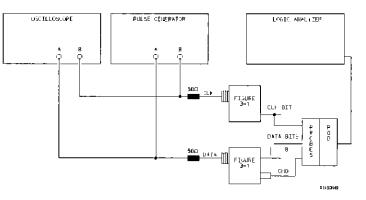
----

| Clock,<br>Qualifier, and<br>Data Inputs<br>Test 1 | <ul> <li>Description: This test verifies maximum clock rate with counting mode for the HP 1650B/51B. This test also verifies the setup and hold times for the falling edge of the HP 1650B L clock specification, and the falling edge of the HP 1651B J and K clock specification.</li> <li>Specification: Clock repetition rate: with time or state counting mode on, minimum time between states is 60 ns.</li> </ul> |
|---------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                                                   | Setup time: Data must be present prior to clock transition; $\geq 10$ ns.                                                                                                                                                                                                                                                                                                                                                |
|                                                   | HP 1650B hold time: Data must be present after falling edge of L clock transition; 0 ns.                                                                                                                                                                                                                                                                                                                                 |
|                                                   | HP 1651B hold time: Data must be present after falling edge of J and K clock transition, 0 ns.                                                                                                                                                                                                                                                                                                                           |
|                                                   | Equipment:                                                                                                                                                                                                                                                                                                                                                                                                               |
|                                                   | Pulse Generator                                                                                                                                                                                                                                                                                                                                                                                                          |

| 50 Ohm Feedthru | (2) |            |                 | <br>HP 10100C |
|-----------------|-----|------------|-----------------|---------------|
| Test Connector  | see | figure 3-1 | • • · · · · · • | <br>          |

#### **Procedure:**

1. Connect the HP 1650B\51B and test equipment as in figure 3-2.





Note 🕕

In this setup, only eight channels are tested at a time to minimize loading. Ground lead must be connected to ensure accurate test results.

#### 2. Adjust pulse generator for the output in figure 3-3.

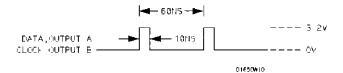


Figure 3-3. Waveform for Data Test 1

#### Setting for HP 8161A:

| Parameter                  | Output A      | Output B |
|----------------------------|---------------|----------|
| Input Mode<br>Period (PER) | Norm<br>60 ns |          |
| Width (WID)                | 10 ns         | 10 ns    |
| Leading Edge (LEE)         | 1 ns          | 1 ns     |
| Trailing Edge (TRE)        | 1 ns          | 1 ns     |
| High Level (HIL)           | 3.2 V         | 3.2 V    |
| Low Level (LOL)            | 0 V           | 0 V      |
| Delay (DEL)                | 0 ns          | 0 ns     |
| Output Mode                | ENABLE        | ENABLE   |

3. Assign the pod under test to **Analyzer 1** in the **System Configuration** as in 3-4. Refer to steps a through c if unfamiliar with menu.

| System Canfiguration<br>Headyzer I<br>Nome: [HeffINE, ]<br>Type: State<br>Pad I | Roolyzer 2<br>Type Off | Unassigned Fods |
|---------------------------------------------------------------------------------|------------------------|-----------------|
|                                                                                 |                        | Ped 5           |

Figure 3-4. System Configuration for Data Test 1

- a. Move cursor to Type field of Analyzer 1 and SELECT.
- b. Set the analyzer Type to State using cursor and SELECT.
- c. Move cursor to Pod to be tested and assign to Machine 1.

4. In the State Format Specification assign Clock Period >60 ns. Also assign lower 8 channels of the pod under test to a label as shown in next figure. If testing HP 1650B then assign falling edge of L clock for all pods. If testing HP 1651B then assign falling edge of J clock for all pods. Refer to steps a through c if unfamiliar with the menus.

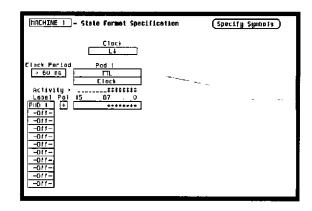
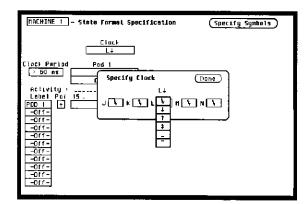


Figure 3-5. State Format Specification for Data Test 1

- a. Press front-panel FORMAT key.
- b. Move cursor to **Clock** field of menu. Use cursor and **SELECT** key to set appropriate clock for falling edge as in next figure.





c. Move cursor to the bit assignment field and turn on appropriate eight bits to be tested (\* = on; . = off) as in figure below.

| Inchine         Inchine <thinchine< th=""> <th< th=""><th>(Specify Symbols)</th></th<></thinchine<> | (Specify Symbols) |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------|
| Clock Pertod         Ped 1           2 60 ns         TTL           Clock         Clock           Activity                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |                   |

Figure 3-7. Bit Assignment for Data Test 1

5. Set up the State Trace Specification without sequencing levels and set Count States as in next figure.

| HACHINE   - State Trace Specification<br>Trace mode Single |          |
|------------------------------------------------------------|----------|
| Sequence Levels                                            | Hrmed by |
| (1) While storing "any state<br>Trigger on "a" I times     | Ruh      |
|                                                            | Granches |
| 2 Store - any state:                                       |          |
|                                                            | Count    |
|                                                            | States   |
|                                                            | Prestore |
|                                                            | 011      |
| Lábel - FOD I                                              |          |
| Bose · Hew                                                 |          |
|                                                            |          |
| b ×4                                                       |          |
|                                                            |          |
|                                                            |          |
|                                                            |          |
|                                                            |          |

Figure 3-8. Trace Specification for Data Test 1

- a. Press front-panel TRACE key.
- b. Move cursor to **Count**, press **SELECT**, then move cursor to **States**, press **SELECT**, and set to any **state** by pressing **SELECT** again.

-----

6. Press RUN. The State Listing is displayed and shows Fs for the channels under test, when test is passed, as in figure 3-9.

|   | MACHINE<br>18Fkør\$ | 1 - Siate | Listing |  |  |
|---|---------------------|-----------|---------|--|--|
|   | Label               | POD 1     | States  |  |  |
|   | Base                |           | Rel     |  |  |
|   | +0000               | FF        | ú       |  |  |
|   | +0001<br>+0002      | FF        | 0       |  |  |
|   | +0002               | FF        | 0       |  |  |
|   | +0003               | FF        | 0       |  |  |
|   | +0005               | FF        | 0       |  |  |
|   | +0005               | FF        | 0       |  |  |
|   | +0007               | FF        | ñ       |  |  |
|   | +0008               | FF        | ň       |  |  |
|   | +0009               | FF        | 'n      |  |  |
| - | +0010               | FF        | ŭ       |  |  |
|   | +0011               | FF        | ō       |  |  |
|   | +0012               | fF        | ū       |  |  |
|   | +0013               | FF        | Ċ       |  |  |
|   | +0014               | FF        | ů       |  |  |
|   | +0015               | FF        | Ū.      |  |  |
|   |                     |           |         |  |  |



Note

To ensure consistent pattern of Fs in listing, use front-panel ROLL field and knob to scroll through **State Listing**.

- 7. If testing the HP 1651B, connect the K clock of Pod 2 to the test connector and repeat steps 4 and 6 for the falling edge of K clock.
- 8. Remove the probe tip assembly from the logic analyzer probe cable and attach to the next logic analyzer probe cable to be tested. Take care not to dislodge grabbers from the test connector. If testing the HP 1651B then re-assign the falling edge of J clock.
- 9. Repeat steps 3, 4, 6 and 7 until all pods have been tested.
- 10. Disconnect lower eight bits (bits 0 through 7) from test connector. Attach upper eight bits (bits 8 through 15) to the test connector.
- 11. Repeat steps 3, 4, 6, 7 and 8 until the upper bits of all pods have been tested.

 Clock, Qualifier, and Data Inputs Test 2

**Description**: This test verifies the setup and hold time specification for the rising edge transition of all clocks on the HP 1650B/51B.

#### Specification:

Setup time: Data must be present prior to clock transition;  $\geq 10$  ns.

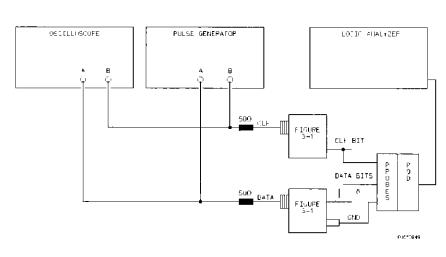
Hold time: Data must be present after rising clock transition; 0 ns.

#### Equipment:

| Pulse Generator     | P 8161A/020 |
|---------------------|-------------|
| Oscilloscope ,      | . HP 54502A |
| 50 Ohm Feedthru (2) | HP 10100C   |
| Test Connectors (2) | figure 3-L  |

#### Procedure:

1. Connect the HP 1650B\51B and test equipment as in figure 3-10.





Note 此

In this setup, only eight channels are tested at a time to minimize loading. Ground lead must be connected to ensure accurate test results.

2. Adjust pulse generator for the output in figure 3-11. Pulse generator settings are different for HP 1650B and HP 1651B.

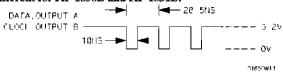


Figure 3-11. Waveform for Data Test 2

Setting for HP 8161A:

| Parameter                  | Output  | A Output B |
|----------------------------|---------|------------|
| Input Mode<br>Period (PER) | Norm    |            |
| HP 1650B                   | 28.5 ns |            |
| HP 1651B<br>Width (WID)    | 40 ns   |            |
| HP 1650B                   | 18.5 ns | 18 5ns     |
| HP 1651B                   | 30 ns   | 30 ns      |
| Leading Edge (LEE)         | 1 ns    | 1 ns       |
| Trailing Edge (TRE)        | 1 ns    | 1 ns       |
| High Level (HIL)           | 32 V    | 3.2 V      |
| Low Level (LOL)            | 0 V     | 0 V 0      |
| Delay (DEL)                | 0 ns    | 0 ns       |
| Output Mode                | ENABLE  | ENABLE     |

- 3. Assign the pod under test to Analyzer 1 in System Configuration as in previous test figure 3-4.
- 4. In the State Format Specification assign Clock Period <60 ns, and rising edge of J clock. Also, assign lower 8 channels of the pod under test to a label as in figure 3-12.

| [MACHINE 1] - State Formot Specification              | (Specify Symbols) |
|-------------------------------------------------------|-------------------|
| Clock<br>J†                                           |                   |
| Clock Period Pod  <br>< <u>60 ns</u><br>Clock         |                   |
| Activity >\$1\$111111<br>Label Pol 15 87 0<br>FOD 1 + |                   |
| -011-<br>-011-<br>-011-                               |                   |
| -011-<br>-011-<br>-011-                               |                   |
| -110-<br>-011-<br>-011-                               |                   |
|                                                       |                   |



----

- -- - ----

5. Set the State Trace Specification without sequencing levels and set Count to Off as in Figure 3-13.

| MACHENE<br>Markors | 1 - <u>Stote Listing</u><br>Off |  |
|--------------------|---------------------------------|--|
| Label              | • P0 >                          |  |
| Bose               | Hex                             |  |
| H0000              | 00                              |  |
| H0001              | 00                              |  |
| +0002              | 00                              |  |
| H0003              | 00                              |  |
| H0004              | 00                              |  |
| H0005              | 00                              |  |
| 10006              | 00                              |  |
| H0007              | 00                              |  |
| +0006              | 00                              |  |
| H0009              | 00                              |  |
| +0010              | 00                              |  |
| +0011              | DC                              |  |
| H0012              | 00                              |  |
| +0013              | 00                              |  |
| +0014              | 00                              |  |
| +0015              | 00                              |  |

Figure 3-13. State Listing for Data Test 2

6. Press RUN. The State Listing is displayed and lists all 0s for the channels under test, if passed test, as in figure 3-14.

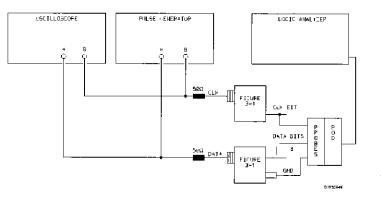


Figure 3-14. Setup for Data Test 3



-----

To ensure consistent pattern of 0s in listing, use front-panel ROLL keys and knob to scroll through **State Listing**.

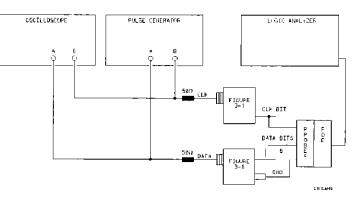
HP 1650B/1651B Service Manual Performance Tests 3-11

- 7. Connect the next clock to the test connector and repeat steps 4 and 6 for the appropriate clock. Repeat until all clocks have been tested (clocks J, K, L, M and N).
- 8. Remove the probe tip assembly from the logic analyzer probe cable and attach to the next logic analyzer probe cable to be tested. Take care not to dislodge grabbers from the test connector.
- 9. Repeat steps 3, 4, 6 and 7 until all pods have been tested (pods 1 through 5). Start again with the rising edge of J clock and test the pod with all clocks.
- 10. Repeat until the lower bits of all pods have been tested (pods 1 through 5).
- Disconnect lower eight bits (bits 0 through 7) from test connector. Attach upper eight bits (bits 8 through 15) to the test connector. Repeat steps 3, 4, 6, 7, and 8 until the upper bits of all pods have been tested (pods 1 through 5).

| Clock,<br>Qualifier, and<br>Data Inputs<br>Test 3<br>(HP 1650B<br>Only) | <b>Description:</b> This performance test verifies the hold time specification for the falling clock transitions of the J, K, M and N clock on the HP 1650B. <b>Specification:</b> HP 1650B Hold time: Data must be present after falling J, K, M and N clock transition; 1 ns. <b>Equipment:</b> |
|-------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                                                                         | Pulse Generator                                                                                                                                                                                                                                                                                   |

# 

#### 1. Connect the HP 1650B and test equipment as in figure 3-15.





Note 🕕

In this setup, only eight channels are tested at a time to minimize loading. Ground lead must be connected to ensure accurate test results.

2 Adjust pulse generator for the outputs in figure 3-16.

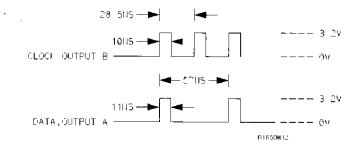


Figure 3-16. Waveform for Data Test 3

Performance Tests 3-13

#### Setting for HP 8161A:

| Parameter           | Output A | Output B |
|---------------------|----------|----------|
| Input Mode          | Norm     |          |
| Period (PER)        | 57 ns    |          |
| Width (WID)         | 11 ns    | 10 ns    |
| Leading Edge (LEE)  | 1 ns     | 1 ns     |
| Trailing Edge (TRE) | 1 ns     | l ns     |
| High Level (HIL)    | 3.2 V    | 32V      |
| Low Level (LOL)     | 0 V 0    | 0 V      |
| Delay (DEL)         | 0 ns     |          |
| Double Pulse (DBL)  |          | 28.5 ns  |
| Output Mode         | ENABLE   | ENABLE   |

- 3. Assign the pod under test to Analyzer 1 in the System Configuration as in previous test figure 3-4.
- 4. In the State Format Specification menu assign Clock Period < 60 ns, and falling edge of J clock. Also, assign the lower 8 channels of the pod under test to a label as in figure 3-12.
- 5. Set the State Trace Specification without sequencing levels and set Count Off as in previous figure 3-13.
- 6. Press RUN. The State Listing is displayed and lists alternating Fs and 0s as in figure 3-17, if test has passed.

| MACHINE | I - State Listing |
|---------|-------------------|
| -       |                   |
| Narkers | Off               |
|         |                   |
|         |                   |
| Label : | POD T             |
| Base    | · []əy            |
| +0000   | 00                |
| +00001  | FF                |
| +0001   | 00                |
| +0003   | FF                |
| +0004   | ÜÜ                |
| +0005   | FF                |
| +0006   | ΩΩ                |
| +0007   | FF                |
| +0008   | 00                |
| +0009   | FF                |
| +00 (0  | 00                |
| +0011   | FF                |
| +0012   | (1()              |
| +0013   | FF                |
| +0014   | 00                |
| +0015   | FF                |
|         |                   |

Figure 3-17. State Listing for Data Test 3



To ensure consistent pattern of alternating Fs and 0s, use the front-panel ROLL field and knob to scroll through **State Listing**.

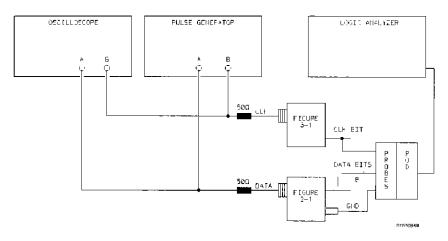
- 7. Connect the next clock to the test connector and repeat steps 4 and 6 for the appropriate clock. Repeat until the J, K, M and N clocks have been tested.
- 8. Remove the probe tip assembly from the logic analyzer probe cable and attach to the next logic analyzer probe cable to be tested. Take care not to dislodge grabbers from the test connector. Repeat steps 3, 4, 6 and 7 until all pods have been tested (pods 1 through 5). Start again with the falling edge of the J clock and test the pod with all clocks except L clock.

9. Disconnect lower eight bits (bits 0 through 7) from test connector. Attach upper eight bits (bits 8 through 15) to the test connector. Repeat steps 3, 4, 6, 7 and 8 until the upper bits of all pods have been tested (pods 1 through 5).

| Clock,<br>Qualifier, and | <b>Description:</b> This test verifies the minimum swing voltages of the input probes and the maximum clock rate of the HP 1650B\51B when it is in single phase mode. |
|--------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Data Inputs              | Specification:                                                                                                                                                        |
| Test 4                   | Minimum swing: 600 mV peak-to-peak.                                                                                                                                   |
|                          | HP 1650B Clock repetition rate: Single phase is 35 MHz maximum.                                                                                                       |
|                          | HP 1651B Clock repetition rate: Single phase is 25 MHz maximum.                                                                                                       |
|                          | Clock pulse width: $\geq 10$ ns at threshold.                                                                                                                         |
|                          | Equipment:                                                                                                                                                            |
|                          | Pulse Generator                                                                                                                                                       |

**Procedure:** 

1. Connect the HP 1650B\51B and test equipment as in figure 3-18. In order to most accurately measure the amplitude of the test signals from the pulse generator, high impedance scope probes should be used to look at the signal levels at the output of the pulse generator.





Note 此

In this setup, only eight channels are tested at a time to minimize loading. Ground lead must be connected to ensure accurate test results. It is recommended that all eight channel grounds be connected.

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# 2. Adjust pulse generator for the output in figure 3-19. Pulse generator settings are different for HP 1650B and HP 1651B.

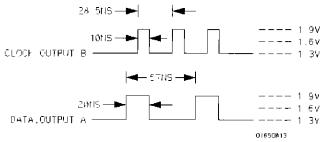


Figure 3-19. Waveform for Data Test 4

Setting for HP 8161A:

| Parameter           | Output A | Output B        |
|---------------------|----------|-----------------|
| Input Mode          | Norm     |                 |
| Period (PER)        |          |                 |
| HP 1650B            | 57 ns    |                 |
| HP 1651B            | 80) ns   |                 |
| Width (WID)         | 20 ns    | 10 ns           |
| Leading Edge (LEE)  | 1 ns     | 1 ns            |
| Trailing Edge (TRE) | 1 ns     | l ns            |
| High Level (HIL)    | 1.9V     | 1.9V (see Note) |
| Low Level (LOL)     | 1.3V     | 1.3V (see Note) |
| Delay (DEL)         |          |                 |
| HP 1650B            | 18.5 ns  |                 |
| HP 1651B            | 30 ns    |                 |
| Double Pulse (DBL)  |          |                 |
| HP 1650B            |          | 28.5 ns         |
| HP 1651B            |          | 40 ns           |
| Output Mode         | ENABLE   | ENABLE          |

Note 🕕

The voltage levels of the waveforms must have the correct amplitude at the logic analyzer probe tips. The pulse generator output may have to be increased slightly to compensate for loading by the logic analyzer.

- 3. Assign the pod under test to Analyzer 1 in System Configuration as in previous figure 3-4.
- 4. In the State Format Specification assign Clock Period <60 ns, and rising edge of J clock. Also, assign lower 8 channels of the pod under test to a label as in previous figure 3-12.
- 5. Set the State Trace Specification without sequencing levels and set Count Off as in previous test figure 3-13.

6. Press RUN. The State Listing is displayed and shows alternating Fs and 0s for the channels under test as in figure 3-20.

| (MACHINE 1) – <u>State Listing</u><br>Markers <u>Off</u> |   |
|----------------------------------------------------------|---|
| Label > POD 1 T<br>Bisa > Her                            |   |
| +0000 00                                                 |   |
| +0001 FF                                                 |   |
| +0002 00                                                 |   |
| +0003 FF                                                 |   |
| +0004 00                                                 |   |
| +0005 FF                                                 |   |
| <u>40006</u> 00                                          |   |
| +0007 FF                                                 |   |
| +0008 00                                                 |   |
| +(10119 FF                                               |   |
| +0010 00                                                 |   |
| +0011 FF                                                 |   |
| +0012 00                                                 |   |
| +0013 FF                                                 |   |
| +0014 00                                                 | 1 |
| +0015 FF                                                 |   |

Figure 3-20. State Listing for Data Test 4



To ensure consistent pattern of alternating Fs and 0s, use the front-panel ROLL keys and knob to scroll through **State Listing**.

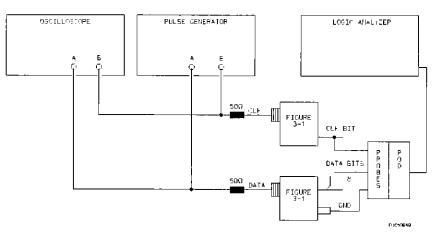
- 7. Connect the next clock to the test connector and repeat steps 4 and 6. Repeat until all clocks have been tested (clocks J, K, L, M and N).
- 8. Remove the probe tip assembly from the logic analyzer probe cable and attach to the next logic analyzer probe cable to be tested. Take care not to dislodge grabbers from the test connector.
- 9. Repeat steps 3, 4, 6 and 7 until all pods have been tested (pods 1 through 5). Start again with the rising edge of J clock and test the pod with all clocks.
- 10. Repeat until the lower bits of all pods have been tested (pods 1 through 5).
- 11. Disconnect lower eight bits (bits 0 through 7) from test connector. Attach upper eight bits (bits 8 through 15) to the test connector.
- 12. Repeat steps 3, 4, 6, 7 and 8 until the upper bits of all pods have been tested (pods 1 through 5).

| Clock,<br>Qualifier, and | <b>Description:</b> This performance test verifies the maximum clock rate for mixed mode clocking during state operation.                                                                                                                                                                                                                        |
|--------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Data Inputs              | Specification:                                                                                                                                                                                                                                                                                                                                   |
| Test 5                   | Clock repetition rate: HP 1650B single phase is 35 MHz maximum, HP 1651B is 25 MHz. With time or state counting, minimum time between states is 60 ns (16.7 MHz maximum). Both mixed and demultiplexed clocking use master-slave clock timing; master clock must follow slave clock by at least 10 ns and precede the next slave clock by 50 ns. |
|                          | Equipment:                                                                                                                                                                                                                                                                                                                                       |

| Pulse Generator                | HP | 8161A/020 |
|--------------------------------|----|-----------|
| Oscilloscope                   |    |           |
| 50 Ohm Feedthru (2)            |    |           |
| Test Connectors see figure 3-1 |    | (2)       |

#### **Procedure:**

1. Connect the HP 1650B/51B and test equipment as in figure 3-21 by connecting channels 0-3 and 8-11 of the pod under test to the test connector. On the slave clock transition the four bits of the lower byte are transferred to the logic analyzer, and on the master clock transition the four bits of the upper byte are transferred to the logic analyzer.







In this setup, only eight channels are tested at a time to minimize loading. Ground lead must be connected to ensure accurate test results.

Performance Tests 3-18

#### 2. Adjust pulse generator for the output in figure 3-22.

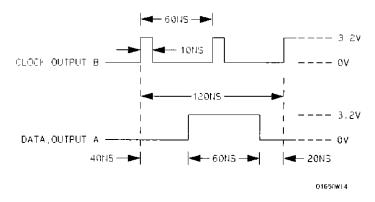


Figure 3-22. Waveform for Data Test 5

Setting for HP 8161A:

| Parameter           | Output A | Output B |
|---------------------|----------|----------|
| Input Mode          | Norm     |          |
| Period (PER)        | 120 ns   |          |
| Width (WID)         | 60 ns    | 10 ns    |
| Leading Edge (LEE)  | 1 ns     | l ns     |
| Trailing Edge (TRE) | 1 ns     | 1 ns     |
| High Level HIL)     | 3.2 V    | 3.2 V    |
| Low Level (LOL)     | 0 V      | 0 V      |
| Delay (DEL)         | 40 ns    |          |
| Double Pulse (DBL)  |          | 60 ns    |
| Output Mode         | ENABLE   | ENABLE   |

- 3. Assign the pod under test to Analyzer 1 in the System Configuration as in previous figure 3-4.
- 4. Set up the **State Format Specification** as in figure 3-23, assigning the falling J clock to **Master Clock** and the rising J clock to **Slave Clock**. Refer to steps a through d after figure if unfamiliar with the menu.

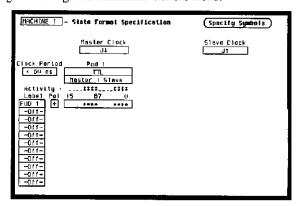


Figure 3-23. State Format Specification for Data Test 5

- a. Move cursor to Clock field and SELECT, then assign Mixed Clocks.
- b. Assign falling transition of the J clock to Master Clock and rising transition of the J clock to Slave Clock.
- c. Assign channels 0-3 and 8-11 of the pod under test.
- d. Set Clock Period to >60 ns.
- 5. Set the State Trace Specification without sequencing levels and Count Off as in previous figure 3-13.
- 6. Press RUN. The State Listing displays alternating Fs and 0s for the channels under test as in figure 3-24.

| MACHINE       | I - State Listing |
|---------------|-------------------|
| Markers       | 110               |
|               |                   |
| Lebul<br>Base | + POU 1<br>• He×  |
| +0000         | ))O               |
| +0000         | ITE               |
| +0001         | DG                |
| +00013        | i F               |
| +0004         | 00                |
| +0005         | TF .              |
| +0006         | DG                |
| +0007         | I'F               |
| +0008         | 06                |
| +0009         | TF                |
| +0010         | DO                |
| +≎0it         | FF                |
| 40012         | 00                |
| +0013         | FF                |
| H0014         | 90                |
| H0015         | ۴F                |

Figure 3-24. State Listing for Data Test 5



To ensure consistent pattern of alternating Fs and 0s, use the front-panel ROLL field and knob to scroll through **State Listing**.

- 7. Connect the next clock to the test connector and repeat steps 4 and 6. Repeat until all clocks have been tested (clocks J, K, L, M and N).
- 8. Remove the probe tip assembly from the logic analyzer probe cable and attach to the next logic analyzer probe cable to be tested. Take care not to dislodge grabbers from the test connector.
- 9. Repeat steps 3, 4, 6 and 7 until all pods have been tested (pods 1 through 5). Start again with the falling edge of J clock as the Master and rising edge of the J clock as the Slave clock. Repeat until channels 0 3 and 8 11 of all pods have been tested (pods 1 5).
- 10. Disconnect bits 0-3 and bits 8-11 from the test connector. Attach bits 4-7 and bits 12-15 to the test connector. Repeat steps 3, 4, 6, 7 and 8 until all pods have been tested (pods 1 through 5).

# Clock, Qualifier, and Data Inputs Test 6

**Description:** This performance test verifies the maximum clock rate for demultiplexed clocking during state operation.

#### Specification:

Clock repetition rate: HP 1650B single phase 35 MHz maximum, HP 1651B single phase 25 MHz. With time or state counting, minimum time between states is 60 ns (16.7 MHz maximum). Both mixed and demultiplexed clocking use master-slave clock timing; master clock must follow slave clock by at least 10 ns and precede the next slave clock by 50 ns.

#### **Equipment:**

| Pulse Generator     |                                       | HP 8161A/020   |
|---------------------|---------------------------------------|----------------|
| Oscillscope         |                                       |                |
| 50 Ohm Feedthru (2) | • • • • • • • • • • • • • • • • • • • | HP 10100C      |
| Test Connectors (2) |                                       | see figure 3-1 |

#### **Procedure:**

1. Connect the HP 1650B/51B and test equipment as in figure 3-25 by connecting channels 0-7 of the pod under test to the test connector. During demultiplexed clocking only the lower eight bits of each pod are used.

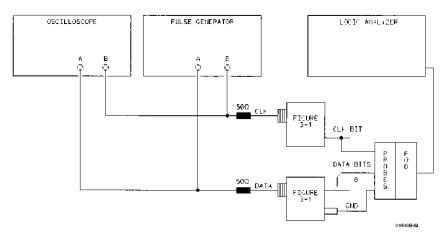
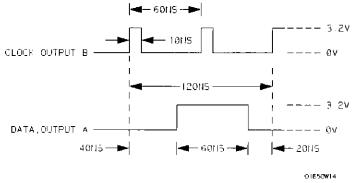


Figure 3-25. Setup for Data Test 6



#### 2. Adjust pulse generator for the output in figure 3-26.

Figure 3-26. Waveform for Data Test 6

Setting for HP 8161A:

| Parameter           | Output A | Output B |
|---------------------|----------|----------|
| Input Mode          | Norm     |          |
| Period (PER)        | 120 ns   |          |
| Width (WID)         | 60 ns    | 10 ns    |
| Leading Edge (LEE)  | 1 ns     | 1 ns     |
| Trailing Edge (TRE) | l ns     | 1 ns     |
| High Level (HIL)    | 32 V     | 3.2 V    |
| Low Level (LOL)     | 0 V      | 0 V      |
| Delay (DEL)         | 40 ns    |          |
| Double Pulse (DBL)  |          | 60 ns    |
| Output Mode         | ENABLE   | ENABLE   |
|                     |          |          |

- 3. Assign the pod under test to Analyzer 1 in System Configuration as in previous figure 3-4.
- 4. Set up **State Format Specification** as in figure 3-27, assigning the falling J clock as **Master Clock** and the rising J clock as **Slave Clock**. Refer to steps a through d after figure if unfamiliar with the menus.

| [HACHINE 1] - State Formet Specification                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         | (Specify Symbols) |
|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------|
| Master Cloc⊧<br>J∔                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               | Slave Clock       |
| Clack Period Pod 1<br>1 60 ms TTL<br>Histor   Sinum<br>Activity trititititititititit<br>Label Pol 7 0° 0<br>POD 1 E EFFECTION 0<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-017-<br>-0 |                   |
|                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |                   |



a. Move cursor to Clock field and SELECT, then assign Demultiplex.

- b. Assign falling clock transition of J clock to Master Clock and rising J clock transition to Slave Clock.
- c. Assign ALL channels to pod under test (only bits 0 through 7 are be available for assignment).
- d. Set Clock Period to < 60 ns.
- 5. Set State Trace Specification without sequencing levels and set Count Off as in previous figure 3-13.
- 6. Press RUN. The State Listing shows alternating Fs and 0s for the pod under test as in figure 3-28.

| <u>HACHINE</u><br>Markars | I - State Listing | ]        |
|---------------------------|-------------------|----------|
|                           |                   | ménara r |
| Bese                      | Hex               |          |
| +0000                     | 0000              |          |
| +0001                     | FFFF              |          |
| +0002                     | 0000              |          |
| +0003                     | FFFF              |          |
| +0004                     | 0000              |          |
| +0005                     | FFFF              |          |
| +0006                     | 0000              |          |
| +0007                     | FFFF              |          |
| +0008                     | 0000              |          |
| +0009                     | FFFF              |          |
| +0010                     | 0000              |          |
| +0011                     | FFFF              |          |
| +0012                     | 0000              |          |
| +0013                     | FFFF              |          |
| +0014<br>+0015            | 0000<br>FFFF      |          |

Figure 3-28. State Listing for Data Test 6



To ensure consistent pattern of alternating Fs and 0s in listing, use front-panel ROLL field and knob to scroll through State Listing.

- 7. Connect the next clock to the test connector and repeat steps 4 and 6.
- 8. Repeat until all clocks have been tested (clocks J, K, L, M and N).
- 9. Remove the probe tip assembly from the logic analyzer probe cable and attach to the next logic analyzer probe cable to be tested. Take care not to dislodge grabbers from the test connector.
- 10. Repeat steps 3, 4, 6 and 7 until all pods have been tested (pods 1 through 5). Start again with the falling edge of J clock as the Master Clock and rising edge of the J clock as the Slave Clock.

## Glitch Test

Description:

This performance test verifies the glitch detection specification of the HP 1650B/51B.

#### Specification:

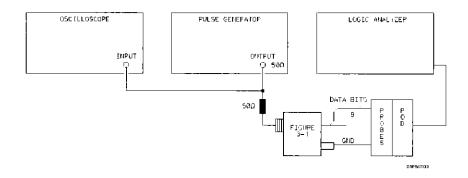
Minimum detectable glitch: 5 ns wide at the threshold.

#### Equipment:

| Pulse Generator        | HP 8161A/020   |
|------------------------|----------------|
| Oscilloscope           | HP 54502A      |
| 50 ohm Feedthrough (1) |                |
| Test Connector (1) s   | see figure 3-1 |

#### Procedure:

1. Connect the test equipment as in figure 3-29. The clock inputs are not used for the glitch test since glitch detection is part of timing analysis. Use the oscilloscope to make sure pulses are 5 ns wide at the threshold (1.6 V).







In this setup, only eight channels are tested at a time to minimize loading. Ground lead must be grounded to ensure accurate test results.

#### 2. Adjust pulse generator for the output in figure 3-30.

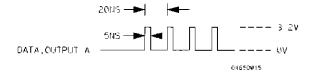


Figure 3-30. Waveform for Glitch Test

#### Setting for HP 8161A:

| Parameter           | Output A | Output B |
|---------------------|----------|----------|
| Input Mode          | Norm     | • =      |
|                     |          |          |
| Period (PER)        | 20 ns    |          |
| Width (WID)         | 5 ns     |          |
| Leading Edge (LEE)  | 1 ns     |          |
| Trailing Edge (TRE) | 1 ns     |          |
| High Level (HIL)    | 3.2 V    |          |
| Low Level (LOL)     | 0 V      |          |
| Delay (DEL)         | 0 ns     |          |
| Output Mode         | ENABLE   |          |

3. Assign the pod under test to Analyzer 1 in System Configuration as in figure 3-31. Refer to steps a and b if unfamiliar with menus.

| Rinelyzer 1<br>Neme: <u>DirectINE 1</u><br>Type- <u>Timing</u><br>( <u>Autoscele</u> ) | Rbalyzer 2<br>Type: | Unessigned Pads |
|----------------------------------------------------------------------------------------|---------------------|-----------------|
|                                                                                        |                     | Pad 4           |

Figure 3-31. System Configuration for Glitch Test

- a. Move cursor to Type field of Analyzer 1 and SELECT.
- b. Set the analyzer Type to Timing using cursor and SELECT.
- c. Move cursor to pod to be tested and assign to Machine 1.
- 4. In State Format Specification assign the lower eight bits of the pod under test to a label as shown in figure 3-32. Make sure the appropriate eight bits in the bit assignment field are turned on.

----

| <u></u> | - |  | - | - | _ | - |
|---------|---|--|---|---|---|---|
|         |   |  |   |   |   |   |

| MACHINE   - Timing Format Specification | (Specify Symbols) |
|-----------------------------------------|-------------------|
|                                         |                   |
| Pad                                     |                   |
|                                         |                   |
| Activity >IIIIIII                       |                   |
| Label Pol 15 87 . 0                     |                   |
| FOD   + +                               |                   |
| -110-                                   |                   |
| -110-                                   |                   |
| -110-                                   |                   |
| -011-1                                  |                   |
| -017-1                                  |                   |
| -110-                                   |                   |
| -011-                                   |                   |
| -110-                                   |                   |
| -011                                    |                   |
| - <u>110-</u>                           |                   |
| -0/1-                                   |                   |
|                                         |                   |

5. Set Timing Trace Specification as in figure 3-33. Follow steps a through c if



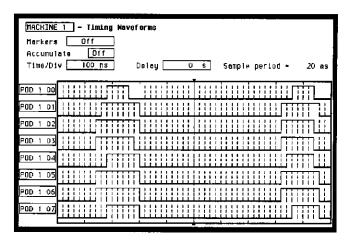
unfamiliar with menu.

- a. Move cursor to Acquisition mode field and SELECT Glitch.
- b. Move cursor to **Find Pattern field and SELECT**. Push DON'T CARE (all Xs) snd SELECT. Set **Present for** field to >30 ns.
- c. Set Then find Glitch on all channels (all \* s).

| TACHINE 1 - Timing Trace Specificat)<br>Trace mode Singly<br>Armed by Pon | Acquisition mode <u>Glitch</u> |
|---------------------------------------------------------------------------|--------------------------------|
| Label > <u>FOD 1</u><br>Bese + <u>Her</u><br>Find<br>Patiern <u>x</u> w   |                                |
| present for 📑 🚺 30 ms                                                     |                                |
| Then fund<br>Edge<br>or<br>Glitch 88                                      |                                |
|                                                                           |                                |

Figure 3-33. Glitch Test Timing Trace Specification

6. Press RUN. The timing analyzer acquires data and shows glitches for channels under test as in figure 3-34. SELECT Delay field and rotate knob to assure consistent glitch detection.







If sample clock and data synchronize, glitches may be displayed on the timing screen as valid data transitions.

- 7. Remove the probe tip assembly from the logic analyzer probe cable and attach to the next logic analyzer probe cable to be tested. Take care not to dislodge grabbers from the test connector.
- 8. Repeat steps 3, 4, and 6 until all pods have been tested (pods 1 through 5). Make sure to assign correct pod to be tested in **System Configuration**.
- 9. Disconnect lower eight bits (bits 0 through 7) from test connector. Attach upper eight bits (bits 8 through 15) to the test connector.
- 10. Repeat steps 3, 4, 6 and 7 until the upper bits of all pods have been tested (pods 1 through 5).

# Threshold Accuracy Test

**Description**: This performance test verifies the threshold accuracy within the three ranges stated in the specification.

#### Specification:

Threshold accuracy: 150 mV accuracy over the range -2.0 to +2.0 volts; 300 mV accuracy over the ranges -9.9 to -2.1 volts and +2.1 to +9.9 volts.

#### **Equipment**:

| Power Supply        |                    |
|---------------------|--------------------|
| Test Connector (1). | <br>see figure 3-1 |

#### **Procedure:**

1. Connect the test equipment as in figure 3-35.

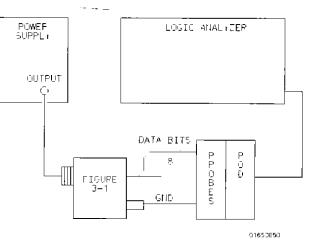


Figure 3-35. Threshold Accuracy Test Setup

Note

In this setup, only eight channels are tested at a time to minimize loading. Ground lead must be grounded to ensure accurate test results.

- 2. Assign the pod under test to Analyzer 1 in System Configuration as in previous figure 3-31.
- 3. Configure Timing Format Specification for User Defined pod threshold of 0.0 V for the pod under test and assign the lower eight bits in the bit assignment field as in figure 3-36. Refer to steps a and b if unfamiliar with menu.
  - a. Move cursor to Pod Threshold field and SELECT. Move cursor to User-defined field and SELECT. Enter the appropriate voltage threshold.

Performance Tests 3-28

b. Move cursor to bit assignment field and turn on the appropriate eight bits to be tested (\* = on; . = off).

| HACHINE ( - Timing Formet Specification                         | (Specify Symbola) |
|-----------------------------------------------------------------|-------------------|
| Ped  <br>+ 0 0 V<br>Activity<br>Lebel Pel 15 - 87 0<br>(PED 1 + |                   |
| -011-<br>-011-<br>-011-<br>-011-<br>-011-<br>-011-              |                   |
| -110-<br>-110-<br>-110-<br>-110-<br>-110-                       |                   |
|                                                                 |                   |



- 4. Set **Timing Trace Specification** as in figure 3-37. Follow steps a through c if unfamiliar with menus.
  - a. Move cursor to Acquisition mode and SELECT Glitch.
  - b. Move cursor to Find Pattern and SELECT. Push DON'T CARE (all X s) and SELECT. Set present for field to >30 ns.
  - c. Set Then find Glitch to all DON'T CARES (all  $\bullet$ s).

| <u>HHCHINE   - Timing Trace Specificat:</u><br>Trace mode Single       | Len                     |
|------------------------------------------------------------------------|-------------------------|
| Armed by Run                                                           | Acquisition mode Glitch |
| Label > <u>POD 1</u><br>Base > <u>He.</u><br>Find<br>Pattern <u>XX</u> |                         |
| present for 🕒 🛛 30 ns                                                  |                         |
| Then find<br>Edge<br>or<br>Gilich                                      |                         |

Figure 3-37. Threshold Accuracy Trace Specification

- 5. Adjust the power supply output for +150 mV.
- 6. Press RUN. Data displayed on Timing Waveforms is be high for the pod and channels under test as in figure 3-38.

| MACHINE<br>Markers<br>Accumula | i - Timing<br>Off | Havefar <b>a</b> s |     |          |          |       |
|--------------------------------|-------------------|--------------------|-----|----------|----------|-------|
| Time/Di-                       |                   | Deley              | 0 5 | ] Semple | period - | 2⊓ ns |
| POD 1 00                       |                   |                    |     |          |          |       |
| POD 1 01                       |                   |                    |     |          |          |       |
| POD 1 03                       |                   |                    | 1   |          |          |       |
| PCD 1 04                       |                   | _                  |     |          |          |       |
| PCD 1 05                       |                   |                    |     |          |          |       |
| POD 1 06<br>POD 1 07           |                   |                    |     |          | -        |       |
|                                |                   |                    |     | <u> </u> |          |       |



7. Adjust power supply output for -150 mV.

- .

8. Press RUN. Data displayed on Timing Waveforms is all low for the channels under test as in figure 3-39.

| tierkers [              | - Fiming He | aveforms |    |               |          |
|-------------------------|-------------|----------|----|---------------|----------|
| Accumulat<br>Time/Div [ |             | Deiay    | 05 | Sample pariod | • 20 n\$ |
| POD 1 00                |             |          |    |               |          |
| POD 1 02                |             |          |    |               |          |
| POD 1 03                |             |          |    |               |          |
| POD 1 05                |             |          |    |               |          |
| POD 1 06                |             |          |    |               |          |
|                         |             |          |    |               |          |

Figure 3-39. Threshold Accuracy Timing Waveforms 2

- 9. Return to Timing Format Specification and change User Defined Pod Threshold to + 9.9 V.
- 10. Adjust power supply for output of +10.2 V.
- 11. Press RUN. Data displayed on **Timing Waveforms** all high for the pod and channels under test as in previous test figure 3-37.
- 12. Adjust power supply for output of +9.6 V.
- 13. Press RUN. Data displayed on **Timing Waveforms** is all low for the pod and channels under test as in previous test figure 3-40.

- 14. Return to the Timing Format Specification and change the User Defined pod threshold to -9.9 V.
- 15. Adjust power supply for output of -9.6 V.
- 16. Press RUN. Data displayed on Timing Waveforms is all high for the pod and channels under test as in previous test figure 3-39.
- 17. Adjust power supply for output of -10.2 V.
- 18. Press RUN. Data displayed on **Timing Waveforms** is all low for the pod and channels under test as in previous test figure 3-40.
- 19. Remove the probe tip assembly from the logic analyzer probe cable and attach to the next logic analyzer probe cable to be tested. Take care not to dislodge grabbers from the test connector.
- 20. Repeat steps 2 through 18 until all pods have been tested (pods 1 through 5).
- 21. Disconnect lower eight bits (bits 0 through 7) from test connector. Attach upper eight bits (bits 8 through 15) to the test connector.
- 22. Repeat steps 2 through 19 until the upper bits of all pods have been tested (pods 1 through 5).

| Hewlett-Packard            | Tested by                                          |         |         |
|----------------------------|----------------------------------------------------|---------|---------|
| Model 1650B/51B            |                                                    |         |         |
| Logic Analyzer             | Work Order No.                                     |         |         |
| Serial                     |                                                    |         |         |
| Number                     |                                                    |         |         |
|                            |                                                    |         |         |
|                            | ended Calibration          1       24       Months |         |         |
|                            |                                                    |         |         |
| Test                       |                                                    | Results |         |
| Clock, Qualifier, and Data |                                                    | Passed  | Failed  |
| Inputs Test 1              | Pod1                                               | 1 40004 | - 0.000 |
| <b>F</b>                   | Pod2                                               |         |         |
|                            | Pod3                                               |         |         |
|                            | Pod4                                               |         |         |
|                            | Pod5                                               |         |         |
| Clock, Qualifier, and Data |                                                    | Passed  | Failed  |
| Inputs Test 2              | Pod1                                               |         |         |
| ·                          | Pod2                                               |         |         |
|                            | Pod3                                               |         |         |
|                            | Pod4                                               |         |         |
|                            | Pod5                                               |         |         |
| Clock, Qualifier, and Data |                                                    | Passed  | Failed  |
| Inputs Test 3              | Pod1                                               |         |         |
|                            | Pod2                                               |         |         |
|                            | Pod3                                               |         |         |
|                            | Pod4                                               |         |         |
|                            | Pod5                                               |         |         |
| Clock, Qualifier, and Data |                                                    | Passed  | Failed  |
| Inputs Test 4              | Pod1                                               |         |         |
|                            | Pod2                                               |         |         |
|                            | Pod3                                               |         | <u></u> |
|                            | Pod4                                               |         |         |
|                            | Pod5                                               |         |         |
| Clock, Qualifier, and Data |                                                    | Passed  | Failed  |
| Inputs Test 5              | Pod1                                               |         |         |
|                            | Pod2                                               |         |         |
|                            | Pod3                                               |         |         |
|                            | Pod4                                               |         |         |
|                            | Pod5                                               |         |         |

Table 3-1. Performance Test Record

Performance Tests 3-32

| Test                                        | Results                                                                                              |
|---------------------------------------------|------------------------------------------------------------------------------------------------------|
| Clock, Qualifier, and Data<br>Inputs Test 6 | Passed         Failed           Pod1            Pod2            Pod3            Pod4            Pod5 |
| Glitch Test                                 | Passed         Failed           Pod1            Pod2            Pod3            Pod4            Pod5 |
| Threshold Accuracy Test                     | Passed         Failed           Pod1                                                                 |

## Table 3-1. Performance Test Record (continued)

# Contents

#### Section 4

# Adjustments Introduction 4-1 Calibration Interval 4-1 Safety Requirements 4-1 Safety Requirements 4-1 Recommended Test Equipment 4-2 Instrument Warmup 4-2 Calibration 4-2 Power Supply Assembly Adjustment 4-3 CRT Monitor Assembly Adjustments 4-4 Intensity, Sub-bright, and Contrast Adjustment 4-4 Focus Adjustment 4-5 Horizontal Phase, Vertical Linearity, and Height Adjustments 4-6 System Board Assembly Threshold Adjustment 4-7 Examples 4-8

| Introduction            | This section provides adjustment procedures for the HP 1650B/51B. The assemblies with adjustments are: the power supply, CRT monitor, and the system board. Figures in this section are the testpoint and adjustment locations for the HP 1650B/51B.                                                                                                                                                                                       |
|-------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Calibration<br>Interval | The recommended calibration interval for the HP 1650B/51B is two years. The adjustments are set at the factory on assemblies when they are tested. However, adjustments may be necessary after repairs have been made to the instrument. Usually the only assembly that may require adjustments is the assembly that has been replaced.                                                                                                    |
| Note                    | An instrument warm-up of 15 minutes is recommended, but not required, before adjustment procedures are performed.                                                                                                                                                                                                                                                                                                                          |
| Warning 🍟               | Read the Safety Summary at the beginning of this manual before performing any adjustment procedures.                                                                                                                                                                                                                                                                                                                                       |
| Caution 🖐               | The adjustment procedures are performed with the top cover of the instrument removed. Take care to avoid shorting or damaging internal parts of the instrument.                                                                                                                                                                                                                                                                            |
| Safety<br>Requirements  | Specific warnings, cautions, and instructions are placed wherever applicable<br>throughout the manual. These must be observed during all phases of operation,<br>service, and repair of the module. Failure to comply with them violates safety<br>standards of design, manufacture, and intended use of this module.<br>Hewlett-Packard assumes no liability for the failure of the customer to comply with<br>these safety requirements. |

| Recommended<br>Test Equipment | Recommended test equipment for calibration and adjustment is listed in table 1-3.<br>Any equipment that satisfies the critical specifications given in the table may be<br>substituted for the recommended models. |  |
|-------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--|
| Warning 🍟                     | Read the safety summary at the front of this manual before any adjustment, replacement, maintenance, or repair is performed.                                                                                       |  |
| Instrument<br>Warmup          | Adjust and calibrate the instrument at it's environmental ambient temperature and after a 15 minute warm-up.                                                                                                       |  |
| Calibration                   | The calibration procedures in this section should be followed in their entirety and in the same sequence as in this section.                                                                                       |  |

| Power Supply<br>Assembly | 1. Disconnect power cord from HP 1650B/51B. Refer to figure 4-1.                                                                                 |
|--------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------|
| Adjustment               | 2. Connect the negative lead of the voltmeter to Power Supply Assembly ground.                                                                   |
|                          | 3. Connect the positive lead of the voltmeter to +5V on the Power Supply Assembly.                                                               |
|                          | <ol> <li>Connect the power cord to the HP 1650B/51B and put power switch in ON<br/>position.</li> </ol>                                          |
|                          | 5. Voltmeter should indicate voltage within the range of $+5.180$ V to $+5.220$ V.                                                               |
|                          | 6. If voltmeter reading is out of this range, adjust +5 ADJ on Power Supply<br>Assembly to +5.200 V % .050 V (+5.180 V to +5.220 V).             |
| Caution 🖐                | High voltages exist on the sweep board that can cause personal injury. Avoid contact with the CRT monitor sweep board when adjusting the $+5V$ . |

-12V +3 5V +5 20V ADJ COM +12V -5.2V +5 20V +12V , Ę, // (azhodo-@ 20 調 W 1 γ W8 54502009



HP 1650B/1651B Service Manual

Adjustments 4-3

# CRT Monitor Assembly Adjustments

## Intensity, Sub-bright, and Contrast Adjustment

1. Refer to figure for adjustment locations.

2. Place **TIMING WAVEFORMS** menu on the screen of the HP 1650B/51B, by pressing front-panel DISPLAY key.

Note

This menu is used because it has characters throughout the screen which are watched during the procedures. Any other menu may be used; however, the adjustments may not be as accurate if characters and/or lines are not displayed throughout the screen.

- 3. Set rear-panel INTENSITY to the minimum setting.
- 4. Adjust sweep board SUB BRIGHT control to the lowest setting of brightness where menu is visible on the CRT screen.



High voltages exist on the sweep board. Avoid contact with the sweep board when making CRT adjustments.

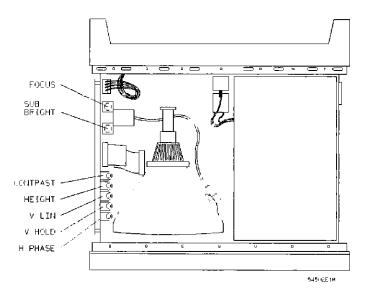


Figure 4-2. CRT Adjustment Locations

Adjustments 4-4

- 5. Turn rear-panel INTENSITY to bring up the intensity level on screen. Screen intensity should be at a comfortable viewing level and the position of both adjustments should be close to mid-range.
- 6. Press RUN and then STOP.
- 7. Adjust CONT so the error message is easily seen.

# **FOCUS** 1. Refer to figure for adjustment locations. **Adjustment**

- 2. Place TIMING WAVEFORMS menu on the screen of the HP 1650B/51B by
- pressing the front-panel DISPLAY key.
- 3. Adjust sweep board FOCUS control for sharp pixels in the center of the screen menu. Note FOCUS control position.
- 4. Adjust sweep board FOCUS for sharp pixels at the corners of the screen. Note FOCUS control position.
- 5. Set sweep board FOCUS control for mid-position between the two positions noted in steps 3 and 4 for best over-all pixel focus.

Horizontal Phase, Vertical Linearity, and Height Adjustments

Note

٩E

1. Refer to figure for adjustment locations.

pressing front-panel DISPLAY key.

This menu is used because it has characters and lines throughout the menu which are watched during the procedures. Any other menu may be used, however, the adjustments may not be as accurate.

2. Place TIMING WAVEFORMS menu on the screen of the HP 1650B/51B by

- Adjust sweep board H. PHASE to center the menu horizontally on the CRT screen.
- 4. Adjust sweep board V. LIN so top and bottom rows of text are equal in height. Text height should be approximately 1mm.

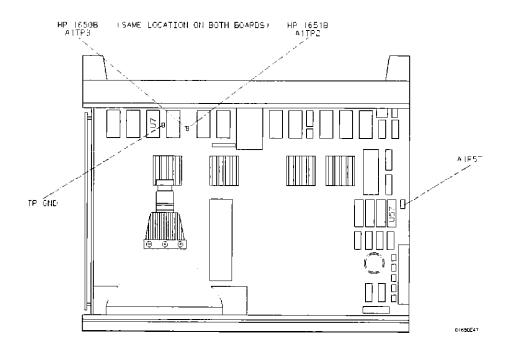
Note

The V. LIN and HEIGHT adjustments are interactive and may need to be repeated as necessary.

- 5. Adjust sweep board HEIGHT to give the screen menu top and bottom borders equal to the side borders of the menu.
- 6. Readjust steps 4 and 5 as necessary for a uniform display of the screen menu.

### System Board Assembly Threshold Adjustment

- 1. Disconnect power cord from HP 1650B/51B.
- 2. Connect negative (-) lead of voltmeter to TP GND. Refer to figure 4-3 for testpoint and adjustment locations.
- 3. Connect positive (+) lead of voltmeter to HP 1650B A1TP3, or HP 1651B A1TP2 on the System Board Assembly.
- 4. Connect power cord to logic analyzer and turn instrument power to ON.



#### Figure 4-3. System Board Testpoints and Adjustments

- 5. Assign HP 1650B POD 3, or HP 1651B POD 2, to a machine in the System Configuration menu by using front-panel knob and SELECT key.
- 6. Set User defined Pod Threshold of the pod assigned in the previous step to -9.9 V in the Format Specification menu by using the following steps if unfamiliar with the menus.

HP 1650B/1651B Service Manual Adjustments 4-7

- a. Press front-panel FORMAT key.
- b. Move cursor to TTL (threshold field) and press SELECT.
- c. Assign User defined threshold by using front-panel knob and SELECT key.
- 7. Voltmeter readout should indicate voltage within the range of -.975 V to -1.005 V (-.990 V % .015 V).
- 8. Set User defined Pod Threshold of the pod assigned in the previous step to +9.9 V in the Format Specification menu.
- 9. Note voltmeter readout. Voltage reading should be within the range of +.975 V to +1.0005 V (+.990 V % .015 V).
- 10. If either voltage reading is not within the given range, use the procedure below to adjust the threshold level.
  - a. Set User defined Pod threshold of the pod assigned to -9.9 V.
  - b. Adjust A1R57 for reading of -.9900 V % .0005 V. Refer to figure 4-3 for adjustment locations.
  - c. Set User defined Pod threshold to +9.9 V.
  - d. Note the difference between this reading and +.9900 V.
  - e. Adjust A1R57 so the difference in step d is halved, % .0005 V.
- **EXAMPLES** If reading is + .9952 V, the difference is .0052 V. Adjust A1R57 for + .9926 V  $\mathcal{C}_{0}$  .0005 V.

If reading is  $\pm$  .9834 V, the difference is .0066 V. Adjust A1R57 for  $\pm$  .9867 V % .0005 V.

Adjustments 4-8

# Contents

| Section 5 | Replaceable Parts         |  |
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|           | Introduction              |  |
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|           | Exchange Assemblies       |  |
|           | Ordering Information      |  |
|           | Direct Mail Order System  |  |

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# **Replaceable Parts**

| Introduction                     | This section contains information for ordering parts. Service support for this instrument is to the assembly level. The replaceable parts include assemblies and chassis parts. Figure 5-1 shows an exploded view of the instrument.                                                                                                                                                                                                                                                         |
|----------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Abbreviations                    | Table 5-1 lists the abbreviations used in the parts list and throughout this manual.<br>Abbreviations in the replaceable parts list are in capital letters. In other sections<br>of this manual abbreviations may be in uppercase or lowercase letters.                                                                                                                                                                                                                                      |
| Replaceable<br>Parts List        | Table 5-2 is a list of replaceable parts and is organized as follows:                                                                                                                                                                                                                                                                                                                                                                                                                        |
|                                  | 1. Electrical assemblies in alphanumerical order by reference designation.                                                                                                                                                                                                                                                                                                                                                                                                                   |
|                                  | 2. Chassis-mounted parts in alphanumerical order by reference designation.                                                                                                                                                                                                                                                                                                                                                                                                                   |
|                                  | Information given for each part consists of the following:.                                                                                                                                                                                                                                                                                                                                                                                                                                  |
|                                  | Reference designation.                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
|                                  | • HP part number.                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
|                                  | • Part number Check Digit (CD).                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
|                                  | • Total quantity (Qty) in the instrument or on the assembly. The total quantity is given once at the first appearance of the part number in the list.                                                                                                                                                                                                                                                                                                                                        |
|                                  | • Description of the part.                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
|                                  | • Typical manufacturer of the part in a five digit code. All parts in this list (except hardware) is manufactured by or for Hewlett-Packard, code is 28480. No list of manufacturers is provided.                                                                                                                                                                                                                                                                                            |
| Exchange<br>Assemblies           | Some of the assemblies used in this instrument have been set up on the exchange program. This allows the customer to exchange his faulty assembly with one that has been repaired, calibrated, and performance verified by the factory. The cost is significantly less than that of a new assembly. The exchange assemblies have a part number in the form XXXXX-695XX.                                                                                                                      |
|                                  | After receiving the repaired exchange assembly from Hewlett-Packard, a United<br>States customer has 30 days to return the faulty assembly. For orders not<br>originating in the United States, contact the local HP service organization. If the<br>faulty assembly is not returned within the warranty time limit, the customer will be<br>charged an additional amount. The additional amount will be the difference in<br>price between a new assembly and that of an exchange assembly. |
| HP 1650B/1651B<br>Service Manual | Replaceable Parts<br>5-1                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |

| Ordering<br>Information     | To order a replaceable part, indicate the HP part number, check digit, and<br>quantity required. Send the order to the nearest HP Sales/Service office.<br>To order a part that is not listed in the replaceable parts table, include the<br>instrument model number, serial number, description and function of part, and<br>total quantity required. Address an order to the nearest HP Sales/Service office.                                                                                                                                                                                                                                                                                                                                                                  |
|-----------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Direct Mail Order<br>System | <ul> <li>Within the USA, Hewlett-Packard can supply parts through a direct mail order system. Advantages of using this system are as follows:</li> <li>Direct ordering and shipment from HP Parts Center, California, U.S.A. Call your local Hewlett-Packard office for the toll free number.</li> <li>No maximum or minimum on any mail order (there is a minimum order amount for parts ordered through local HP offices when orders require billing and invoicing).</li> <li>Prepaid transportation (there is a small handling charge for each order).</li> <li>No invoices.</li> <li>To provide these advantages, check or money order must accompany each order. Mail order forms and specific ordering information are available through your local HP offices.</li> </ul> |

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Replaceable Parts 5-2

|          |                                          | *      | REFERENC                          | E DESIGNATO | 8                                                        |          |                                     |
|----------|------------------------------------------|--------|-----------------------------------|-------------|----------------------------------------------------------|----------|-------------------------------------|
| •        | - assembly                               | F      | -fuse                             | G           | = transistor,SCR,                                        | u        | =integrated circuit.                |
|          | = fan;motor                              | FL     | =filter                           | 4           | triode thyristor                                         | U        | microcircuit                        |
| ar i     | - battery                                | н      | =hardware                         | A           | = resistor                                               | v        |                                     |
| 5        | = capacitor                              | j      |                                   | н<br>н      | = thermistor                                             | •        | = electron tube; glov               |
| CR       |                                          | 5      |                                   | S           |                                                          | VR       | lamp                                |
| μH       | = diode; diode thyristor;                |        | (Stationary portion); jack        |             | = switch;jumper                                          | VH       | =voltage regulator;                 |
|          | varactor                                 | L      | - coll inductor                   | т           | = transformer                                            |          | breakdown diode                     |
| DL.      | = delay line                             | MP     | ≕misc. mechanical part            | TB          | = terminal board                                         | W        | =cable                              |
| DS .     | <ul> <li>annunclator;lamp,LED</li> </ul> | P      | =electrical connector             | TP          | = test point                                             | X        | = socket                            |
|          | =misc. electrical part                   |        | (moveable portion);plug           |             |                                                          | Y        | = crystal unit(piezo-               |
|          |                                          |        |                                   |             |                                                          |          | electric or quariz)                 |
|          |                                          |        | ASBR                              | EVIATIONS   |                                                          |          |                                     |
| 4        | = amperes                                | DWL    | = dowel                           | MFR         | - manufacturer                                           | RIND     | - Round                             |
| vD.      | - analog-to-digital                      | ECL    | -emitter coupled logic            | MICPROC     | = microprocessor                                         | ROM      | = read-only memory                  |
| G        | -alternating current                     | ELAS   | - elastomeric                     | MINTB       | = miniature                                              | RPG      | - rotary pulse genera               |
| ъ        | =adjust(ment)                            | DOT    | = externel                        | MISC        | = miscellaneous                                          | RX       | - leceinel.                         |
| L        | =aluminum                                | F      | = farads:metal film               | MLD         | = molded                                                 |          |                                     |
| L<br>MPL | =amplifier                               | ·      | (resistor)                        | MM          | = malaea<br>= millimeter                                 | 8        | = Schotiky-clamped;                 |
|          |                                          | 50     |                                   |             |                                                          |          | seconds(time)                       |
| NLG      | ≖analog                                  | FC     | = carbon film/                    | MO          | = metal oxide                                            | SCR      | - screw;silicon                     |
| NSI      | -American National                       |        | composition                       | MTG         | = mounting                                               |          | controlled rectifier                |
|          | Standards Institute                      | FD     | ⇒feed                             | MTLC        | = métallic                                               | SEC      | = second (time), secor              |
| SSY      | - assembly                               | FEM    | =female                           | MUX         | – multiplexar                                            |          | dary                                |
| STIG     | - astigmatism                            | FF     | =filp-flop                        | MW          | - millevalt                                              | SEG      | = segment                           |
| SYNCHRO  | = asynchronous                           | FL     | = fiat                            | N           | = nano(10 <sup>-9</sup> )                                | SEL      | = selector                          |
| ITEN     | - attenuator                             | FM     | = foam:from                       | NC          | = no connection                                          | SGL      | = single                            |
| NG       | = American wire gauge                    | FR     | = front                           | NMOS        | = n-channel metal-                                       | SHF      | - shift                             |
| AL.      | = balance                                | FT     | = gain bandwidth                  | CUNICO      |                                                          |          | ⇒ snm<br>= silicon                  |
|          |                                          | C1     |                                   |             | oxida-semiconductor                                      | SI       |                                     |
| GD       | = binary-code decimal                    |        | product                           | NPN         | = negative-positive-                                     | SIP      | ⇔single in-line                     |
| D        | = board                                  | FW     | = ful) weve                       |             | negative                                                 |          | package                             |
| FA       | = buffer                                 | FXD    | =fixed                            | NPEN        | = neoprene                                               | SKT      | = skirt                             |
| N        | =binary                                  | GËN    | = generator                       | NRFA        | = not recommended for                                    | SL       | = slide                             |
| RDG      | - bridge                                 | GND    | = ground(ed)                      |             | field replacement                                        | SLDR     | = solder                            |
| SHG      | - bushing                                | GP     | - general purpose                 | NSR         | - not separately                                         | SLT      | = slot(ted)                         |
| N        | =bandwidth                               | GRAT   | = graticule                       |             | replaceable                                              | SOLD     | - solenoid                          |
|          | = ceramic;cermet                         | GRV    |                                   | NUM         |                                                          | SPCL     |                                     |
|          |                                          |        | = groove                          |             | = numeric                                                |          | - speciai                           |
| ••       | (resistor)                               | H      | = hennes,high                     | OBD         | <ul> <li>order by description</li> </ul>                 | SQ       | = square                            |
| AL.      | = calibrate; calibration                 | HD     | = hardware                        | OCTL        | = octal                                                  | SREG     | =shift register                     |
| G        | = carbon composition                     | HOND   | - hardened                        | OD          | = outside diameter                                       | SRQ      | = service request                   |
| CW       | counterclockwise                         | HG     | = mercury                         | OP AMP      | <ul> <li>operational amplifier</li> </ul>                | STAT     | = static                            |
| ER       | = ceramic                                | HGT    | – height                          | OSC         | = oscillator                                             | STD      | - standard                          |
| FM       | = cubic feet/minute                      | HLCL   | - helical                         | Р           | = plastic                                                | SYNCHRO  | = synchronous                       |
| н        | = choke                                  | HORIZ  | = horizontal                      | P/O         | = part of                                                | TA       | =lantalum                           |
| HAM      | = chamfered                              | HP     | - Hewlett-Packard                 | PC          | - printed circuit                                        | TEAX     | =tubeaxial                          |
| HAN      | =channel                                 | HP IB  | = Hewlett-Packard                 | PCB         | - printed circuit board                                  | TC       | =temperature coeffic                |
| HAR      | - character                              |        | Interface Bus                     | PD          |                                                          | TD I     |                                     |
| M        | = centimeter                             | HB     | = hour(s)                         | PF          | = power dissipation<br>= picofarads (10 <sup>-12</sup> ) |          | =time delay                         |
|          |                                          |        |                                   |             |                                                          | THD      | -thread(ed)                         |
| NOS      | -complementary metal-                    | HV     | = high voltage                    | P           | = plug in                                                | THK      | =thick                              |
|          | oxide semiconductor                      | HZ     | = Hertz                           | PL          | - plate(c)                                               | THAU     | =through                            |
| MR       | = common mode rejec-                     | 1/0    | - input/output                    | PLA         | = programmable  ogic                                     | TP       | =test point                         |
|          | tion                                     | IC     | =Integrated circuit               |             | anay                                                     | TPG      | =tapping                            |
| NDCT     | = conductor                              | ID     | - inside diameter                 | PLST        | - plastic                                                | TPL      | =triple                             |
| NTR      | = counter                                | IN     | =Inch                             | PNP         | = positive-negative-                                     | TRANS    | =transformer                        |
| DN       | = connector                              | INCL   | = include(s)                      |             | positive                                                 | TRIG     | =trigger(ed)                        |
| ONT      | = contact                                | INCAND | ∽ incandescent                    | POLYE       | = polyester                                              | TRMR     | -tringgenjeoj<br>-trimmmer          |
| रा       | = cathode-ray tube                       | INP    | =input                            | POS         |                                                          |          |                                     |
| N        |                                          |        |                                   |             | = positive; position                                     | TRN      | = turn(s)                           |
|          | ≂ clockwise                              | INTEN  | = Intensity                       | POT         | = potentiometer                                          | ΠL       | = transistor-transistor             |
|          | – diameter                               | INTL   | =internal                         | POZI        | = pozidrive                                              | TX       | = transmitter                       |
| A        | = digital-to-analog                      | INV    | - Inverter                        | PP          | = peak-to-peak                                           | U        | — micro(10 <sup>-6</sup> )          |
| NC .     | = digital-to-analog                      | JFET   | -junction field-                  | PPM         | = parts per million                                      | UL       | = Underwriters                      |
|          | converter                                |        | effect transistor                 | PRCN        | = precision                                              |          | Laboratory                          |
| ARL      | = darlington                             | JKT    | -jacket                           | PREAMP      | = preamplifier                                           | UNREG    | - unregulated                       |
| AT       | = data                                   | ĸ      | = kilo(10 <sup>3</sup> )          | PRGMBL      | = programmable                                           | VA       | = voltampere                        |
| BL       | = double                                 | ï      | = low                             | PRL         | = parallel                                               | VAC      |                                     |
| BM       | - decibel referenced                     | ЦВ     | - pound                           | PROG        |                                                          |          | = volt,ac                           |
|          | to 1mW                                   |        |                                   |             | ≂ programmable                                           | VAR      | -vanable                            |
| -        |                                          | LCH    | =latch                            | PSTN        | = position                                               | VCO      | - voltage controlled                |
|          | = direct current                         | LCL    | = local                           | PT          | = point                                                  |          | oscillator                          |
| CDR      | = decoder                                | LED    | = light-emitting                  | PW          | = potted wirewound                                       | VDC      | = volt,dc                           |
| EG       | degræ                                    |        | diode                             | PWR         | - power                                                  | VERT     | = vertical                          |
| emux     | = demultiplexer                          | LG     | = long                            | R-S         | = reset-set                                              | VF       | - voltage filtered                  |
| ET       | = detector                               | U      | = lithium                         | RAM         | = fandom-access                                          | vs       | = Wersus                            |
| A        | - diameter                               | ы́к    | - lock                            |             | memory                                                   | Ŵ        | = waits                             |
| P        | = dual in-line package                   | LKWR   |                                   | PECT        |                                                          |          |                                     |
|          |                                          |        | = lockwasher                      | RECT        | - rectifier                                              | W/       | = with                              |
| V        | = division                               | LS     | - low power Schottky              | RET         | = retainer                                               | W/O      | = without                           |
| MA       | = direct memory access                   | LV     | = low voltage                     | RF          | <ul> <li>radio frequency</li> </ul>                      | WW       | = wirewound                         |
| PDT      | - double-poie,                           | м      | = mega(10 <sup>6</sup> );megohms; | RGLTR       | = regulator                                              | XSTR     | = transistor                        |
|          | double-throw                             |        | meter(distance)                   | RGTR        | = register                                               |          | - zener                             |
| RC       | = DAC refresh controller                 | MACH   | ~ machine                         | RK          | = fack                                                   | ZNA<br>C | = degree Celsius                    |
|          |                                          |        |                                   |             |                                                          | ~        |                                     |
|          | = drwer                                  | MAX    | - maximu (m                       |             |                                                          |          |                                     |
| RVIA     | - driver                                 | MAX    | ⊨ maximum                         | RMS         | root-mean-square                                         | °F<br>°K | (Centigrade)<br>– degree Fahrenheit |

#### Table 5-1. Reference Designator and Abbreviations

HP 1650B/1651B Service Manual Replaceable Parts 5-3

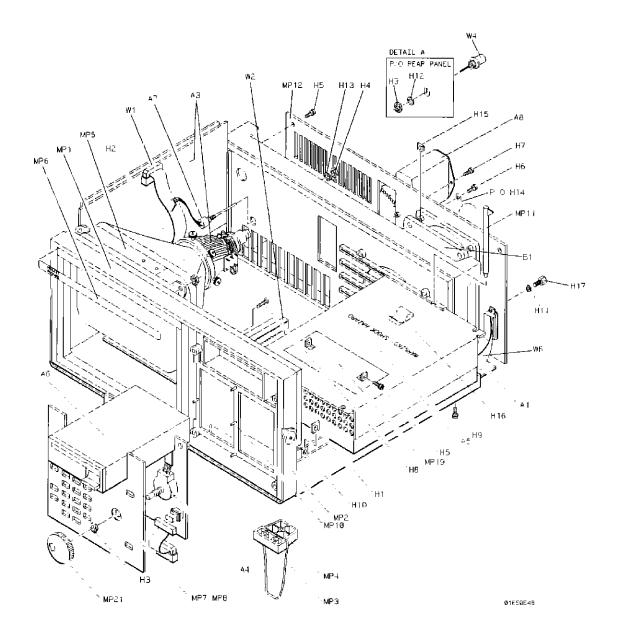


Figure 5-1. HP 1650B/51B Exploded View

Replaceable Parts 5-4

#### Table 5-2. Replaceable Parts List

| Reference  | HP Part                    |    |        |                                                     | Mfr            | Mfr Part                   |
|------------|----------------------------|----|--------|-----------------------------------------------------|----------------|----------------------------|
| Designator | Number                     | CD | Qty    | Description                                         | Code           | Number                     |
| A1         | 01652-66501                |    | 1      | SYSTEM BOARD ASSEMBLY - 80 CHANNEL (1650B)          | 28480          | 01652-66501                |
| A1         |                            |    | 1      | SYSTEM BOARD ASSEMBLY - 32 CHANNEL (1651B)          |                |                            |
|            | 01653-66501                |    |        |                                                     | 28480          | 01653-66501                |
| A2         | 01650-66503                |    | 1      | KEYBOARD CIRCUIT BOARD ASSEMBLY                     | 28480          | 01650-66503                |
| A3         | 2090-0204                  | 9  | 1      | MONITOR ASSEMBLY                                    | 28480          | 2090-0204                  |
| A4         | 0960-0753                  | 6  | 1      | ROTARY PULSE GENERATOR                              | 28480          | 0960-0753                  |
| AF         | 0050 1970                  |    | T      |                                                     | 08480          | 0050 1970                  |
| A5         | 0950-1879                  | 8  |        | POWER SUPPLY ASSEMBLY                               | 28480          | 0950-1879                  |
| A6         | 0950-1798                  | 0  | 1      | DISK DRIVE ASSEMBLY                                 | 28480          | 0950-1798                  |
| A7         | 01650-61614                | 4  | 1      | INTENSITY ADJUSTMENT ASSEMBLY                       | 28480          | 01650-61614                |
| A8         | 9135-0325                  | 8  | 1      | LINE FILTER SWITCH ASSEMBLY                         | 28480          | 9135-0325                  |
| A9         | 01650-61608                | 6  | 5      | PROBE TIP ASSEMBLY (1650B)                          | 28480          | 01650-61608                |
| A9         | 01650-61608                | 6  | 2      | PROBE TIP ASSEMBLY (1651B)                          | 28480          | 01650-61608                |
| B1         | 3160-0429                  | 0  | 1      | FAN-TUBEAXIAL 100-CFM 12VDC                         | 28480          | 3160-0429                  |
|            |                            |    | •      |                                                     | 00.400         | 5050 0000                  |
| E1         | 5959-9333                  | 8  | 0      | REPLACEMENT PROBE LEADS (PKG OF 5)                  | 28480          | 5959-9333                  |
| E2         | 5959-9334                  | 9  | 0      | REPLACEMENT PROBE GROUNDS (PGK OF 5)                | 28480          | 5959-9334                  |
| E3         | 5959-9335                  | 0  | 0      | REPLACEMENT POD GROUNDS (PKG OF 5)                  | 28480          | 5959-9335                  |
| E4         | 5959-0288                  | 4  | 5      | GRABBER ASSEMBLY SET - 20                           | 28480          | 5959-0288                  |
| E4         | 5959-0288                  | 4  | 2      | GRABBER ASSEMBLY SET-20 (1651B)                     | 28480          | 5959-0288                  |
| F1         | 2110-0003                  | D  | 1      | FUSE 3A 250V NTD FE UL                              | 28480          | 2110-0003                  |
| н          | 0535-0113                  | 1  | 10     | NUT "U"-TP M3 X 0.500.3MM-THK (TOP COVER)           | 28480          | 0535-0113                  |
|            |                            |    |        |                                                     |                |                            |
| H2         | 0535-0056                  | 1  | 4      | NUT-HEX PRVLG-TRQ M4 X 0.7 5MM-THK (CRT)            | 28480          | 0535-0056                  |
| H3         | 2950-0001                  | 8  | 3      | NUT-DBL-CHAM 3/8-32-THD0.094-IN-THK (RPG, BNC)      | 28480          | 2950-0001                  |
| H4         | 2950-0072                  | 3  | 1      | NUT-DBL-CHAM 1/4-32-THD0.062-IN-THK (INTEN ADJ)     | 28480          | 2950-0072                  |
| H5         | 0515-0372                  | 2  | 10     | SCREW M3 X 0.5 8MM-LG (DISK DRIVE, REAR PANEL)      | 28480          | 0515-0372                  |
| H6         | 0515-0821                  | 6  | 4      | SCREW- M3.5 X 0.6 (FAN)                             | 28480          | 0515-0821                  |
| HZ         | 0515-1035                  | 6  | 22     | SCREW-M3 X 0.5 8MM- (FEET, LINE FIL, TOP COVER)     |                |                            |
|            |                            |    |        | SUBLIFFINIS A U.S ONINF (FEET, LINE FIL, TUP COVER) | 28480          | 0515-1035                  |
| H8         | 0515-1135                  | 7  | 4      | SCREW- M3 X 0.5 25MM-LG (KEYPAD)                    | 28480          | 0515-1135                  |
| H9         | 0515-1951                  | 5  | 8      | SCREW-TAPPING M4 2 (SYSTEM BOARD)                   | 28480          | 0515-1951                  |
| H10        | 01650-82401                | 1  | 2      | M5 SHOULDER SCREW (HANDLE)                          | 28480          | 01650-82401                |
| H11        | 2190-0009                  | 4  | 2      | WASHER-LK INTL T NO. 80. 168-IN-ID                  | 28480          | 2190-0009                  |
| H12        | 2190-0016                  | 3  | 2      | WASHER-LK INTL T 3/8 IN0.377-IN-ID (BNC)            | 28480          | 2190-0016                  |
|            |                            |    | 1      | ()                                                  |                |                            |
| H13        | 2190-0027                  | 6  | -      | WASHER-LK INTL T 1/4 IN0.256-IN-ID (INTEN ADJ)      | 28480          | 2190-0027                  |
| H14        | 3160-0092                  | 3  | 1      | FAN GUARD                                           | 28480          | 3160-0092                  |
| H15        | 0590-1868                  | 1  | 4      | FAN MOUNTING CLIP                                   | 28480          | 0590-1868                  |
| H16        | 1400-0611                  | 0  | 1      | CLAMP-FL-CA 1-WD (DISK DRIVE CABLE)                 | 28480          | 1400-0611                  |
| H17        | 0380-1482                  | 5  | 2      | HEX STANDOFF 0340 (HP-IB CABLE)                     | 28480          | 0380-1482                  |
| H18        | 01650-00203                |    | 2      | NUT PLATE (HANDLE)                                  | 28480          | 01650-00203                |
| MD4        | 01050 150                  | -  |        |                                                     | 00400          | 046F0 45005                |
| MP1        | 01650-45207                |    | 1      |                                                     | 28480          | 01650-45207                |
| MP2        | 01650-04901                |    | 1      | BALE HANDLE                                         | 28480          | 01650-04901                |
| MP3        | 1460-1345                  | 5  | 2      | TILT STAND SST                                      | 28480          | 1460-1345                  |
| MP4        | 01650-47701                | 0  | 2      | MOLDED FOOT                                         | 28480          | 01650-47701                |
| MP5        | 01650-01202                |    | 1      | GROUND BRACKET                                      | 28480          | 01650-01202                |
|            | 01650 04207                | 1  |        |                                                     | 29495          | 01650 04207                |
|            | 01650-94307<br>01651-94302 |    | 1      | IDENTIFICATION LABEL (1650B)                        | 28480          | 01650-94307                |
| MP6        | - 01661-04909              | 7  | 1      | IDENTIFICATION LABEL (1651B)                        | 28480          | 01651-94302                |
| MP6        |                            |    |        |                                                     |                |                            |
| MP6<br>MP7 | 01650-94306                | 0  | 1      | KEYBOARD LABEL                                      | 28480          | 01650-94306                |
| MP6        |                            | 0  | 1<br>1 | KEYBOARD LABEL<br>KEYBOARD HOUSING                  | 28480<br>28480 | 01650-94306<br>01650-45206 |

HP 1650B/1651B Service Manual Replaceable Parts 5-5

| Table 5-2. Replaceable Parts List (continue |
|---------------------------------------------|
|---------------------------------------------|

| Reference  | HP Part     | 00 | <b>0</b> 1.7 | Description                          | Mfr   | Mfr Part    |
|------------|-------------|----|--------------|--------------------------------------|-------|-------------|
| Designator | Number      | CD | Qty          | Description                          | Code  | Number      |
| MP10       | 01650-45205 | 5  | 1            | KEYBOARD SPACER                      | 28480 | 01650-45205 |
| MP11       | 01650-46101 | 2  | 2            | LOCKING PIN PCB                      | 28480 | 01650-46101 |
| MP12       | 01650-00205 | 1  | 1            | REAR PANEL (1650B)                   | 28480 | 01650-00205 |
| MP12       | 01651-00203 | 0  | 1            | REAR PANEL (1651B)                   | 28480 | 01651-00203 |
| MP13       | 7120-4835   | 0  | 1            | CSA CERTIFICATION LABEL              | 28480 | 7120-4835   |
| MP14       | 01650-04101 | 4  | 1            | TOP COVER                            | 28480 | 01650-04101 |
| MP15       | 01650-84501 | 6  | 1            | ACCESSORY POUCH                      | 28480 | 01650-84501 |
| MP16       | 01650-94303 | 7  | 1            | PROBE LABELS                         | 28480 | 01650-94303 |
| MP17       | 01650-29101 | 6  | 5            | GROUND SPRING (SYSTEM BOARD 1650B) - | 28480 | 01650-29101 |
| MP17       | 01650-29101 | 6  | 2            | GROUND SPRING (SYSTEM BOARD 1651B)   | 28480 | 01650-29101 |
| MP18       | 01650-29102 | 7  | 1            | CLIP RS-232 ESD                      | 28480 | 01650-29102 |
| MP19       | 01650-25401 | 1  | 1            | INSULATOR-ELAN DISK                  | 28480 | 01650-25401 |
| MP20       | 01650-63202 | 0  | 1            | RS-232 LOOPBACK CONNECTOR            | 28480 | 01650-63202 |
| MP21       | 01650-47401 | 7  | 1            | RPG KNOB                             | 28480 | 01650-47401 |
| W1         | 01650-61601 | 9  | 1            | SWEEP CABLE                          | 28480 | 01650-61601 |
| W2         | 54503-61606 | 7  | 1            | POWER SUPPLY CABLE                   | 28480 | 54503-61606 |
| W3         | 01650-61604 | 2  | 1            | DISK CABLE                           | 28480 | 01650-61604 |
| W4         | 01650-61605 | 3  | 2            | BNC CABLE                            | 28480 | 01650-61605 |
| W5         | 01650-61607 | 5  | 5            | PROBE CABLE (1650B)                  | 28480 | 01650-61607 |
| W5         | 01650-61607 | 5  | 2            | PROBE CABLE (1651B)                  | 28480 | 01650-61607 |
| W6         | 01650-61613 | 3  | 1            | HP-IB CABLE                          | 28480 | 01650-61613 |
| W7         | 01650-61616 | 6  | 1            | FAN CABLE                            | 28480 | 01650-61616 |

| Section 6 | Service                                          |      |
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## Service

| descriptions and instructions for use, and signal level tables. The troubleshooting<br>information is provided to isolate a faulty assembly. When a faulty assembly has<br>been located, the disassembly/assembly procedures help direct replacement of the<br>assembly. |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Read the Safety Summary at the front of this manual before servicing the instrument. Before performing any procedure, review it for cautions and warnings.                                                                                                               |
| Maintenance should be performed by trained service personnel aware of<br>the hazards involved (for example, fire and electric shock). When<br>maintenance can be performed without power applied, the power cord<br>should be removed from the instrument.               |
|                                                                                                                                                                                                                                                                          |

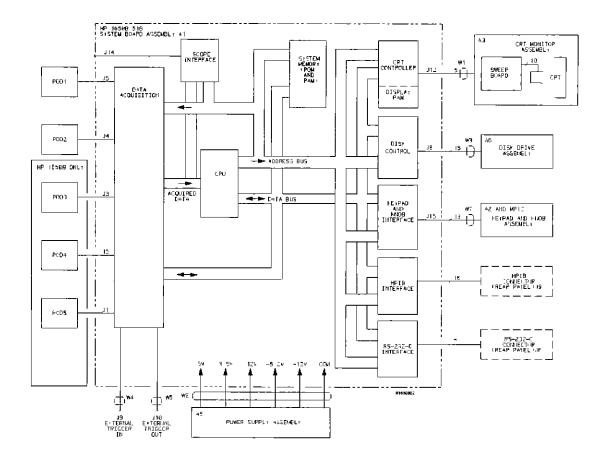


Figure 6-1. Simplified Block Diagram

Service 6-2

| Theory of<br>Operation | The HP 1650B/51B Logic Analyzer is an 80/32 channel state and timing logic<br>analyzer. The human interface is a front-panel keypad and knob for instrument<br>control and 9" (diagonal) white phosphor CRT for information display. Available<br>on the rear panel are RS-232-C and HP-IB ports for communication to a printer or<br>from a controller. Also on the rear panel are two BNCs for input or output of an<br>external trigger.                                                          |
|------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                        | The System Assembly Board is built around the 68000 microprocessor and powerful data acquisition ICs that probe, shape, store, and analyze data from a target system. An acquisition interface to the 68000 makes the acquisition system fully compatible with the architecture of the 68000 microprocessor. The System Assembly contains the necessary circuitry to interface the keypad, CRT monitor, disk drive, RS-232-C and HP-IB ports.                                                        |
|                        | Figure 6-1 is a simplified block diagram of the instrument. The hardware of the HP 1650B/51B consists of four main assemblies. Also shown are rear panel connectors. This manual supports troubleshooting to assembly level. Theory of operation for the System Assembly is included for information only and is not intended for troubleshooting purposes.                                                                                                                                          |
| Data Acquisition       | The data acquisition of the System Assembly consists of the data acquisition pods, acquisition ICs, and the interface to the 68000. The interface to the target system is through any of the data acquisition pods. There are five pods available on the HP 1650B (80 channels) and two pods available on the HP 1651B (32 channels). Each pod contains 16 input data probes and one external clock input for state mode measurements. The data probes can be used for state or timing measurements. |
|                        | Each pod consists of a probe tip assembly and a 4.5 foot woven cable. A probe tip assembly includes 17 twelve-inch probes and a common ground return. This is connected to one end of the cable. The other end of the woven cable terminates at the rear panel of the logic analyzer. The woven cable consists of 17 nichrome signal lines, 34 signal return lines and 2 power supply lines. All are woven together with polyarmid yarn.                                                             |
|                        | Each probe input has an input impedance of 100k ohms in parallel with approximately 8 pF. The probes can be grounded in two ways: with a common pod ground for state measurements, or a probe tip ground for higher frequency measurements.                                                                                                                                                                                                                                                          |
|                        | The input signals are attenuated by a factor of 10 in the passive probe. The signals are applied to a comparator where they are compared against a voltage threshold to determine if the voltage level is above or below the threshold level. The comparator then shapes the single-ended signal and outputs it at an ECL level to the acquisition IC. The input data is then stored at the acquisition IC.                                                                                          |
| Arming Control         | The two BNCs on the rear panel are used for arming control of the logic analyzer acquisition ICs. An arm signal may be output from the ICs to the rear panel EXTERNAL TRIGGER OUT (J10), or input to the ICs from EXTERNAL TRIGGER IN (J9).                                                                                                                                                                                                                                                          |

| Memory                       | The memory of the logic analyzer consists of three separate memories: one ROM<br>and two RAMs. The system (EP)ROM is 64K long by 8 wide and is used primarily<br>for booting-up the system and self-test storage. The system (D)RAM is 1M long<br>by 8 wide and contains the operating system and the acquired data from the target<br>system. Since the RAM is a volatile memory, the operating system is loaded<br>loaded at each power-up of the instrument via the built-in disk drive and a mini<br>floppy disk. |
|------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                              | The display (D)RAM is 64K long by 4 wide and is cycle shared between the 68000 and the display refresh cicuitry. This is why the display bus is separate from the local bus. The two buses are separated by a set of address multiplexers and data buffers.                                                                                                                                                                                                                                                           |
| CRT Controller               | The CRT controller provides the synchronization and timing signals needed by the CRT Monitor Assembly to drive the CRT.                                                                                                                                                                                                                                                                                                                                                                                               |
|                              | The controller generates four signals: Horizontal sync, vertical sync, display<br>enable and a 6.25 kHz signal. The horizontal and vertial sync signals are applied to<br>the CRT monitor assembly and to display PALs. The display PALs use the sync<br>signals to generate the timing signals for the display RAM.                                                                                                                                                                                                  |
|                              | The CRT Monitor Assembly consists of the sweep board circuitry, a 9-inch white phosphor display CRT, and the CRT yoke. The assembly requires $+5$ and $+12$ volts, which it receives from the power supply via the System Board Assembly.                                                                                                                                                                                                                                                                             |
| Disk Controller              | The disk controller performs the necessary functions for reading or writing data to<br>the built-in disk drive of the logic analyzer. The disk controller interface to the<br>68000 is an 8-bit bidirectional bus for data, status, and control word transfers.                                                                                                                                                                                                                                                       |
|                              | The built-in disk drive is a 3.5-inch double-sided Sony disk drive. The main features of the disk drive are low power consumption, low height, and high reliability with simple mechanism and electronic circuitry.                                                                                                                                                                                                                                                                                                   |
| Keypad and Knob<br>Interface | The keypad and knob interface provide the circuitry to latch and send the keypad and knob data to the 68000.                                                                                                                                                                                                                                                                                                                                                                                                          |
|                              | The keypad is elastomeric and each key has a single function.                                                                                                                                                                                                                                                                                                                                                                                                                                                         |
| RS-232-C<br>Interface        | The controlling IC of the RS-232-C Interface is a Signetics SCN2661 Enhanced<br>Programmable Communications Interface (EPCI), a universal<br>synchronous/asynchronous receiver/transmitter (USART) data<br>communications IC.                                                                                                                                                                                                                                                                                         |
|                              | The SCN2661 serializes parallel data from the 68000 for transmission. At the same time, it also receives serial data and converts it to parallel data characters for the 68000.                                                                                                                                                                                                                                                                                                                                       |
|                              | The IC contains a baud rate generator which can be programmed from the logic analyzer I/O menu for one of eight baud rates. Protocol, word length, stop bits length, and parity are also programmed via the I/O menu                                                                                                                                                                                                                                                                                                  |

The DS14C88 and DS14C89 are line drivers/receivers used by the logic analyzer for interface of terminal equipment with data communications equipment. Slew rate control is provided on the ICs eliminating the need for external capacitors.
 Power Supply Assembly The switching power supply provides 120 W (200 W maximum) for the instrument. The ac input to the power supply is 115V or 230 V, -25 to +15%. Maximum input power is 350 VA maximum. The ac input frequency is 48 - 66 Hz.
 All voltages necessary to operate the instrument are applied first to the System Assembly. Unfiltered voltages of +12V, -12V, +5.2V, -5.2V and +3.5V are supplied to the board where they are then filtered and distributed throughout the board and to the CRT Monitor Assembly. Filtered voltages of approximately +5 V and +12 V are routed through the System Assembly to the CRT Monitor Assembly. The +5.2 V supply is adjustable on the supply.

| Trouble<br>Isolation | The trouble isolation flowcharts are the troubleshooting guide. Start there when repairing a defective instrument.                                                                                                                                             |
|----------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Flowcharts           | The flowcharts refer to other tests, tables, and procedures to help isolate trouble.<br>Disassembly procedures are included to direct in replacing faulty assemblies. The<br>circled numbers on charts indicate the next chart to use for isolating a problem. |

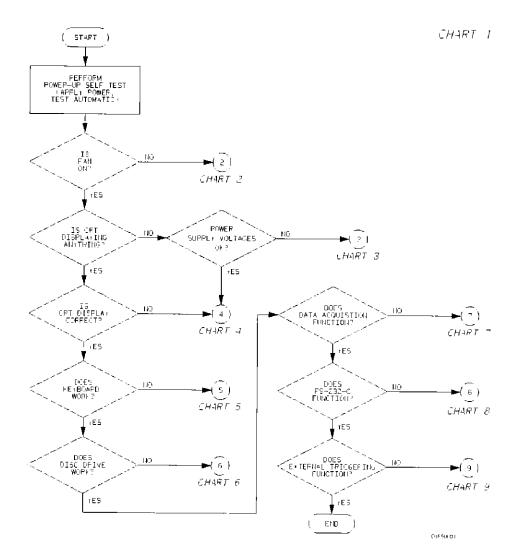


Figure 6-2. Primary Troubleshooting Flowchart

HP 1650B/1651B Service Manual

Service \_\_\_\_\_

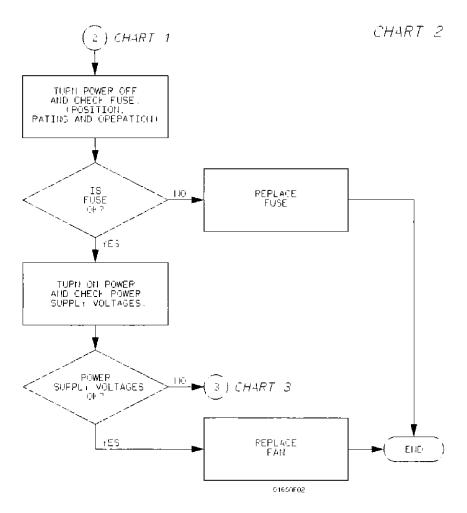


Figure 6-3. Trouble Isolation Flowchart for Fan/Fuse

HP 1650B/1651B Service Manual

- ---- -

Service 6-7

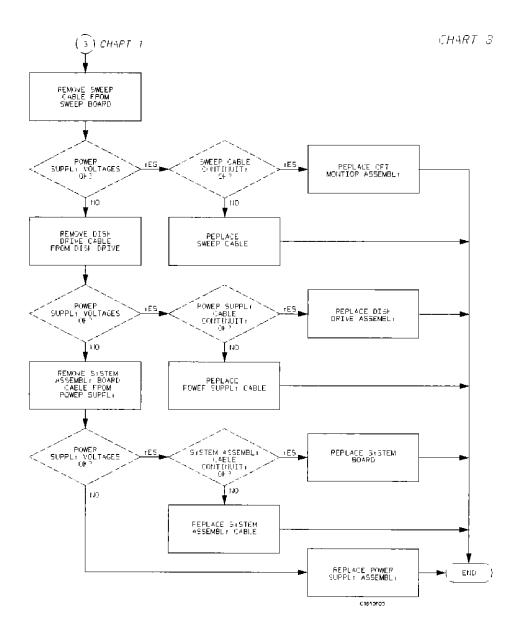


Figure 6-4. Trouble Isolation for Power Supply

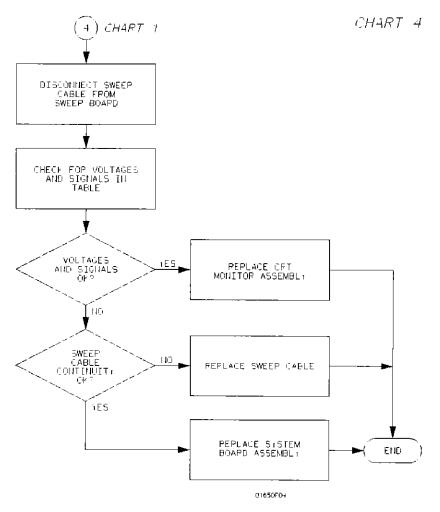


Figure 6-5. Trouble Isolation for CRT Monitor

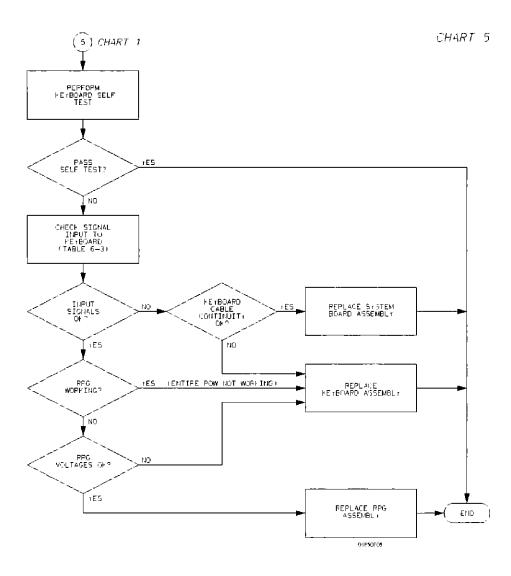


Figure 6-6. Trouble Isolation for Flowchart

Service 6-10

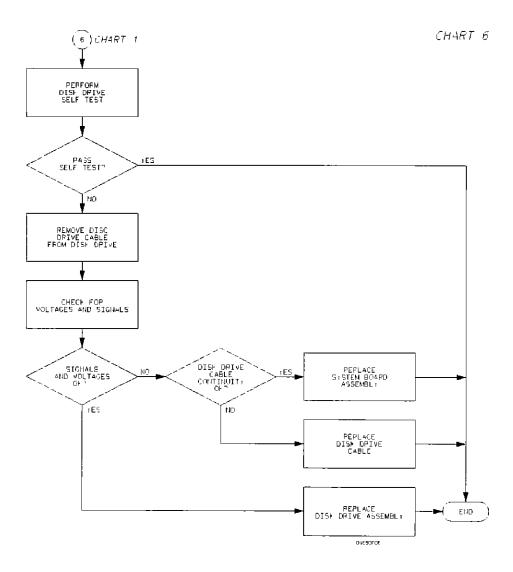


Figure 6-7. Trouble Isolation for Disk Drive

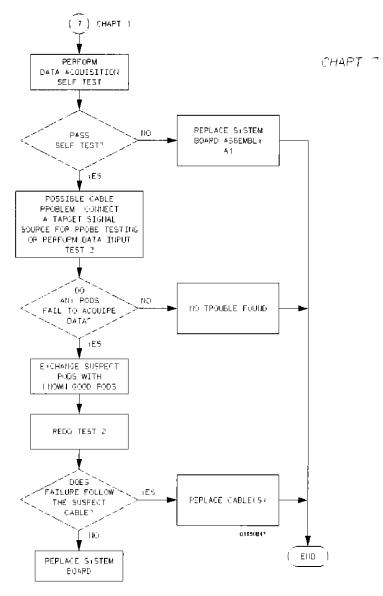


Figure 6-8. Trouble Isolation for Data Acquisition

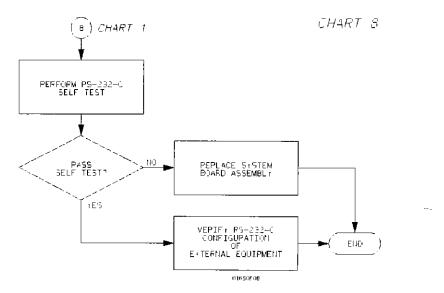


Figure 6-9. Trouble Isolation for RS-232-C

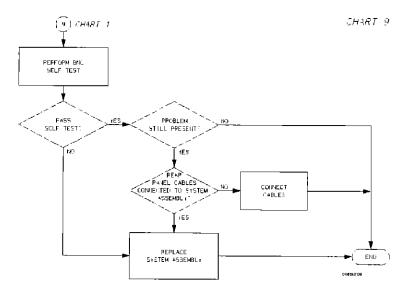


Figure 6-10. Trouble Isolation for BNC

Power Supply Voltages Check

The power supply must be loaded by either the System Assembly Board or with an added resistor to check the voltages.

Warning

This procedure is to be performed only by service-trained personnel aware of the hazards involved (such as fire and electrical shock).

#### Power Supply Loaded by System Assembly

- 1. Remove instrument top cover.
- 2. Using the figure below, check for the voltages indicated at the testpoints.

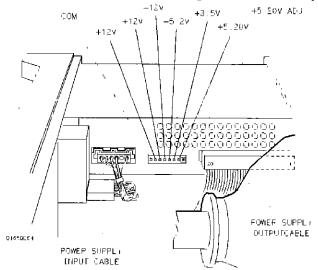


Figure 6-11. Power Supply Test Points

#### **Power Supply Isolated**

Isolate and check the supply with the following steps. Use the figure above for reference.

- 1. Remove instrument power cable.
- 2. Disconnect supply output cable at supply (see figure above).
- 3. Load + 5.20 V supply with a 2 ohm 25 watt resistor. Use jumper wires to connect one end of the resistor to any of pins 1-4, and the other end to any of pins 5-8.

Service 6-14 4. Reconnect instrument power cable and check for voltages at the supply output using values in the following table.

| PIN | SIGNAL           | PIN | SIGNAL          |
|-----|------------------|-----|-----------------|
| 1   | +5.20 V          | 11  | -5.2 V          |
| 2   | +5.20 V          | 12  | GROUND          |
| 3   | +5.20 V          | 13  | +12 V           |
| 4   | +5.20 V          | 14  | GROUND          |
| 5   | GROUND (Display) | 15  | -12 V           |
| 6   | GROUND (Digital) | 16  | GROUND          |
| 7   | GROUND (Digital) | 17  | +12 V (Display) |
| 8   | GROUND           | 18  | -5.2 V          |
| 9   | +3.5 V           | 19  | +15.5 V (Fan)   |
| 10  | GROUND           | 20  | GROUND (Fan)    |

Note 🏙

The ground planes (digital, fan, and display) are at the same potential on the power supply, but when measuring on the main assembly the supplies must be measured with reference to the respective ground.

#### CRT Monitor Signals Check

- 1. Remove instrument top cover.
- 2. Check the CRT Monitor input cable for the signals and supplies listed in the table below. The cable is the wide ribbon cable connecting the monitor to the System Assembly Board.
- 3. Dynamic video signals FB (Full-bright) and HB (Half-bright) are TTL inputs. Check for activity on these lines. The table includes a truth table for these signals.

| PIN | SIGNAL           | PIN | SIGNAL           | FB                                            | HB | VIDEO |
|-----|------------------|-----|------------------|-----------------------------------------------|----|-------|
| 1   | +5 V (Digital)   | 2   | +L2 V (Display)  | 0                                             | 0  | 0FF   |
| 3   | GROUND (Display) | 4   | GROUND (Display) | 0                                             | 1  | HALF  |
| 5   | +12 V (Display)  | 6   | GROUND (Display) | 1                                             | 0  | FULL  |
| 7   | +12 V (Display)  | 8   | GROUND (Display) | 1                                             | 1  | FULL  |
| 9   | +12 V (Display)  | 10  | HSYNC            | <u>الــــــــــــــــــــــــــــــــــــ</u> |    |       |
| 11  | VSYNC            | 12  | +12 V (Display)  |                                               |    |       |
| 13  | GROUND (Digital) | 14  | GROUND (Digital) |                                               |    |       |
| 15  | GROUND (Display) | 16  | F8 (Full-bright) |                                               |    |       |
| 17  | GROUND (Display) | 18  | HB (Half-bright) |                                               |    |       |
| 19  | GROUND (Display) | 20  | +5 V (Digital)   |                                               |    |       |

Table 6-2. CRT Monitor Input Cable Pin Assignments

# Check

Keyboard Signals Isolate a faulty elastomeric keypad or keyboard when random key(s) not operating by performing the following steps.

- 1. Remove instrument power cable.
- 2. Without disconnecting the keyboard cable, follow keyboard removal procedure to loosen keyboard. Leave keyboard in place in front of instrument.
- 3. Apply power.
- 4. Run Keyboard Self Test and press all keys.
- 5. Allow keyboard assembly to fall forward from front panel. Separate the elastomeric keypad and keyboard panel from the PC board.
- 6. Short PC board trace (with a paper clip or screwdriver) of non-operating key and look for appropriate response on display.
- 7. If display responds as if key were pressed, replace elastomeric keypad.
- 8. If display does not respond as if key were pressed, replace keyboard.

The RPG connector has a TTL pulse on pins 1 and 3, when the knob is being turned. Pin 5 of the connector is + 5 V.

The ROW (scan) signal is approximately 60 Hz, a low duty-cycle pulse. It is continually present on pins 11 through 18 of the keyboard cable. Because of the resistance of the keypad contacts, the signal does not appear the same on the COLUMN (data) pins when keys are pressed. Refer to the following table for signals going to and from the keyboard.

| PIN | SIGNAL          | P [ N | SIGNAL           |
|-----|-----------------|-------|------------------|
|     |                 |       |                  |
| 1   | RPGA            | 2     | RPGB             |
| 3   | COLUMN 1 (Data) | 4     | COLUMN 2 (Data)  |
| 5   | COLUMN 3 (Data) | 6     | COLUMN 4 (Data)  |
| 7   | COLUMN 5 (Data) | 8     | COLUMN 6 (Data)  |
| 9   | COLUMN 7 (Data) | 10    | COLUMN 8 (Data)  |
| 11  | ROW 8 (Scan)    | 12    | ROW 7 (Scan)     |
| 13  | ROW 6 (Scan)    | 14    | ROW 5 (Scan)     |
| 15  | ROW 4 (5can)    | 16    | ROW 3 (Scan)     |
| 17  | ROW 2 (Scan)    | 18    | ROW 1 (Scan)     |
| 19  | +5 V (Digital)  | 20    | GROUND (Digital) |
|     |                 |       |                  |

| Table 6-3. Keyboard Connector | Voltages | and Signals |
|-------------------------------|----------|-------------|
|-------------------------------|----------|-------------|

# Assembly<br/>Removal and<br/>ReplacementThis section contains the procedures for removal and installation of major<br/>assemblies. Read the Safety Summary at the front of this manual before servicing<br/>the instrument.WarningImage: Warning Image: Warnin

Never remove or install any assembly with the instrument power ON. Componer damage can occur.



The effects of ELECTROSTATIC DISCHARGE may damage components. Use grounded wriststraps and mats when servicing the System Assembly Board.

#### Removal and Replacement of System Assembly Board

- 1. Disconnect pod cables from rear of instrument.
- 2. Disconnect power cable.
- 3. Remove ten screws securing top cover. Remove top cover.
- 4. Disconnect disk drive cable from disk drive.
- 5. Remove two screws securing disk drive to power supply. Remove disk drive by sliding assembly out front panel of instrument.
- Remove two retaining pins securing power supply to chassis. Slide power supply out far enough to gain unobstructed access to power supply cables.
- 7. Disconnect power supply line input and DC output cables. Remove power supply.
- 8. Disconnect video sweep cable, BNC trigger cables, disk drive cable, keyboard cable, fan cable, power supply DC output cable, and HP-IB cable from system board.
- 9. Remove eight screws securing rear panel to chassis. Remove rear panel.
- 10. Remove RS-232 ESD ground spring from RS-232 connector.
- 11. Carefully place instrument in a front-panel-down position (or on its side) and remove eight screws securing system board to chassis (on underside of instrument).
- 12. Carefully slide system board out rear of instrument.
- 13. Carefully slide new system board through rear of instrument.

14. Secure system board to chassis with eight screws.

Note

Hand-start the self-tapping screws securing the system board. Otherwise, if the holes are not aligned, damage to the board will result.

- 15. Set instrument upright. Install RS-232 ESD spring ground on RS-232 connector. Ensure angled wing tabs of spring ground points toward rear of instrument.
- 16. Place rear panel close enough to chassis to route cables through the rear of the instrument.
- 17. Install rear panel. Ensure cables slide completely through rear of chassis. Secure panel to instrument with eight screws.
- Connect HP-IB cable, power supply DC output cable, fan cable, keyboard cable, disk drive cable, BNC trigger cable, and video sweep cable to system board.

Note

Ensure BNC trigger cables are properly connected to system board. The EXTERNAL TRIGGER INPUT is connected to J9 of the system board, and the EXTERNAL TRIGGER OUTPUT is connected to J10 of the system board.

- 19. Slide power supply in far enough to connect line input cable and DC output cable. Connect cables and slide power supply in completely. Secure power supply using two retaining pins.
- 20. Slide disk drive through front panel of instrument. Secure disk drive to power supply using two screws.
- 21. Connect disk drive cable to disk drive.
- 22. Install top cover. Secure top cover to chassis using ten screws.



To ensure top cover is properly installed, secure side screws of top cover before securing top screws.

23. Verify instrument performance by executing Extended Performance Verification program on Operating System disk.

| <b>Removal and</b>            | 1. Disconnect pod cables from rear of instrument.                                                                                                                                                                                                          |
|-------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Replacement of<br>CRT Monitor | 2. Disconnect power cable.                                                                                                                                                                                                                                 |
| Assembly                      | 3. Remove ten screws securing top cover. Remove top cover.                                                                                                                                                                                                 |
|                               | 4. Connect a jumper lead between ground lug of CRT and shaft of a<br>screwdriver. To discharge CRT, place screwdriver under protestive rubber<br>cap of post accelerator lead and momentarily touch screwdriver to metal clip<br>of post accelerator lead. |
| Caution 🖐                     | Discharge the post accelerator lead to a grounding lug only. Components will be damaged if the post accelerator is discharged to other areas.                                                                                                              |
| Note                          | The CRT may charge by itself even while disconnected. Discharge the CRT before handling by shorting the post accelerator terminal of the CRT to the ground lug with a jumper lead.                                                                         |
|                               | 5. Disconnect post accelerator lead from CRT by firmly squeezing rubber cap<br>until metal clip disengages from CRT.                                                                                                                                       |
|                               | 6. Detach intensity cable from sweep board.                                                                                                                                                                                                                |
|                               | <ol><li>Disconnect sweep cable assembly from sweep board and CRT cables from<br/>from CRT and Sweep board.</li></ol>                                                                                                                                       |
|                               | 8. Slide sweep board up and out of cabinet slot.                                                                                                                                                                                                           |
| Note                          | When installing sweep board, it may be necessary to press on center of outer shield<br>of sweep board to allow the board to clear cabinet support rib.                                                                                                     |
|                               | 9. Carefully place instrument in front-panel-down position.                                                                                                                                                                                                |
|                               | 10. To remove CRT, remove the four locknuts securing the CRT to front panel.<br>Remove CRT and ground bracket from front panel of instrument.                                                                                                              |
| Note                          | When installing CRT, make certain that CRT yoke is properly aligned. THE<br>GROUND BRACKET MUST BE INSTALLED BEFORE THE CRT.                                                                                                                               |
|                               | 11. To install CRT Monitor Assembly, reverse this procedure.                                                                                                                                                                                               |
| Note 🗳                        | After replacement of CRT Monitor Assembly, perform the CRT adjustment procedures in section 4 of this manual.                                                                                                                                              |

#### Removal and Replacement of Power Supply

- 1. Disconnect pod cables from rear of instrument.
- 2. Disconnect power cable.
- 3. Remove ten screws securing top cover. Remove top cover.
- 4. Disconnect disk drive cable from disk drive.
- 5. Remove two screws securing disk drive to power supply. Remove disk drive by sliding assembly out front panel of instrument.
- 6. Remove two retaining pins securing power supply to chassis. Slide power supply out far enough to gain unobstructed access to power supply cables.
- 7. Disconnect power supply line input and DC output cables. Remove power supply.
- 8. Slide new power supply in far enough to connect line input cable and DC output cable. Connect cables and slide power supply in completely. Secure power supply using two retaining pins.
- 9. Slide disk drive through front panel of instrument. Secure disk drive to power supply using two screws.
- 10. Connect disk drive cable to disk drive.
- 11. Install top cover. Secure top cover to chassis using ten screws.



To ensure top cover is properly installed, secure side screws of top cover before securing top screws.

#### Removal and Replacement of Fan

- 1. Disconnect pod cables from rear of instrument.
- 2. Disconnect power cable.
- 3. Remove ten screws securing top cover. Remove top cover.
- 4. Disconnect fan cable and BNC trigger cables from system board.
- 5. Disconnect AC power supply cable from power supply.
- 6. Remove two hex standoffs securing HP-IB cable to rear panel.
- 7. Remove eight screws securing rear panel. Remove rear panel.



An ESD spring ground is inserted on the RS-232 connector. This spring ground is not secured and can easily fall off.

- 8. Detach fan from rear panel by removing four screws securing fan to rear panel.
- 9. Disconnect fan cable from old fan and connect to new fan.

- 10. Align new fan on back panel with fan cable adjacent to line filter assembly and label toward rear (fan rotor is facing forward).
- 11. Align fan guard on back of panel.
- 12. Attach fan to rear panel with four machine screws.
- 13. Re-assemble instrument in reverse order of above.
- 14. Install top cover. Secure top cover to chassis using ten screws.

Note

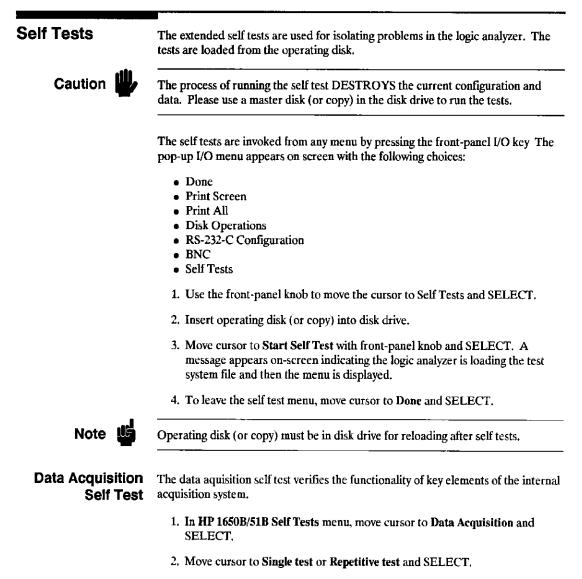
To ensure top cover is properly installed, secure side screws of top cover before securing top screws.

#### Removal and Replacement of Keyboard Assembly

- 1. Disconnect pod cables from rear of instrument.
- 2. Disconnect power cable.
- 3. Remove ten screws securing top cover. Remove top cover.
- 4. Disconnect disk drive cable from disk drive.
- Remove two screws securing disk drive to power supply. Remove disk drive by sliding assembly out front panel of instrument.
- Remove two retaining pins securing power supply to chassis. Slide power supply out far enough to gain unobstructed access to power supply cables.
- 7. Disconnect power supply line input and DC output cables. Remove power supply.
- 8. Disconnect keyboard cable from system board.
- 9. Remove four screws securing keyboard assembly to chassis (located on inside of instrument).
- 10. Remove keyboard assembly.
- 11. Disconnect RPG cable from keyboard circuit board assembly. Keyboard assembly can now be disassembled.
- 12. Reinstall keyboard assembly by reversing this procedure.
- 13. Install top cover. Secure top cover to chassis using ten screws.

Note 🔣

To ensure top cover is properly installed, secure side screws of top cover before securing top screws.



- 3. If running repetitive test press and hold STOP to end test. The number of runs and failures are displayed in the menu.
- 4. To return to HP 1650B/51B Self Tests menu, move cursor to Done and SELECT.

- **RS-232-C Self Test** The RS-232-C self test verifies the functionality of the RS-232-C driver and continuity of the RS-232-C data paths. Connect the RS-232-C loopback connector to the rear-panel RS-232-C port before beginning this test.
  - 1. In HP 1650B/51B Self Tests menu, move cursor to RS-232-C and SELECT.
  - 2. Move cursor to Single test or Repetitive test and SELECT.
  - 3. If running repetitive test press and hold STOP to end test. The number of runs and failures are displayed in the menu.
  - 4. To return to HP 1650B/51B Self Tests menu, move cursor to Done and SELECT.
  - **BNC Self Test** The BNC self test verifies the functionality of the internal BNC trigger circuitry1. In HP 1650B/51B Self Tests menu, move cursor to RS-232-C and SELECT
    - 1. In HP 1650B/51B Self Tests menu, move cursor to BNC and SELECT.
    - 2. Move cursor to Single test or Repetitive test and SELECT.
    - 3. If running repetitive test press and hold STOP to end test. The number of runs and failures are displayed in the menu.
    - 4. To return to HP 1650B/51B Self Tests meau, move cursor to Done and SELECT.

Keyboard SelfThe keyboard self test verifies the key closures and and knob operation on the<br/>front panel system.

- 1. In HP 1650B/51B Self Tests menu, move cursor to Keyboard and SELECT.
- 2. Move cursor to Execute and SELECT.
- 3. Press all keys on front panel and rotate knob to verify proper operation.
- 4. Press STOP twice to return to Keyboard Self Test.
- 5. To return to HP 1650B/51B Self Tests menu, move cursor to Done and SELECT.
- **RAM Self Test** The RAM self test verifies the operation of system RAM and display RAM.
  - 1. In HP 1650B/51B Self Tests menu, move cursor to RAM and SELECT.
  - 2. Move cursor to Single test or Repetitive test and SELECT.
  - 3. If running repetitive test press and hold STOP to end test. The number of runs and failures are displayed in the menu.
  - 4. To return to HP 1650B/51B Self Tests menu, move cursor to Done and SELECT,

**ROM Self Test** The ROM self test verifies the operation of the system ROM.

- 1. In HP 1650B/51B Self Tests menu, move cursor to ROM and SELECT.
- 2. Move cursor to Single test or Repetitive test and SELECT.
- 3. If running repetitive test press and hold STOP to end test. The number of runs and failures are displayed in the menu.
- 4. To return to HP 1650B/51B Self Tests menu, move cursor to Done and SELECT.

Disk Drive Self The disk drive self test verifies the functionality of key elements of the internal disk system.

- 1. In HP 1650B/51B Self Tests menu, move cursor to Disk Drive and SELECT.
- 2. Move cursor to Single test or Repetitive test and SELECT.
- 3. If running repetitive test press and hold STOP to end test. The number of runs and failures are displayed in the menu.
- 4. To return to HP 1650B/51B Self Tests menu, move cursor to Done and SELECT.

**Cycle Through** The following tests are run consecutively and continually until STOP is pressed: **Tests** 

- Data Acquisition
- RAM
- ROM
- Disk Drive

To see reults of continuous tests, move cursor to one of the four tests listed on the menu and SELECT. The number of runs and failures are displayed for that test. To return to **HP 1650B/51B Self Tests**, press SELECT.

**Auxiliary Power** The +5 volts auxiliary power to the logic analyzer pods is protected by a current limiting circuit on the System Assembly Board. If current on pins 1 and 39 of the logic analyzer pods exceeds 2.3 amps, the current limiting circuit opens. After the path causing the excessive current is opened, the circuit resets in approximately 20 ms. If a problem is suspected with this circuit, remove all loads from the pods and measure for +5 volts at either pin 1 or 39 of the pod.